

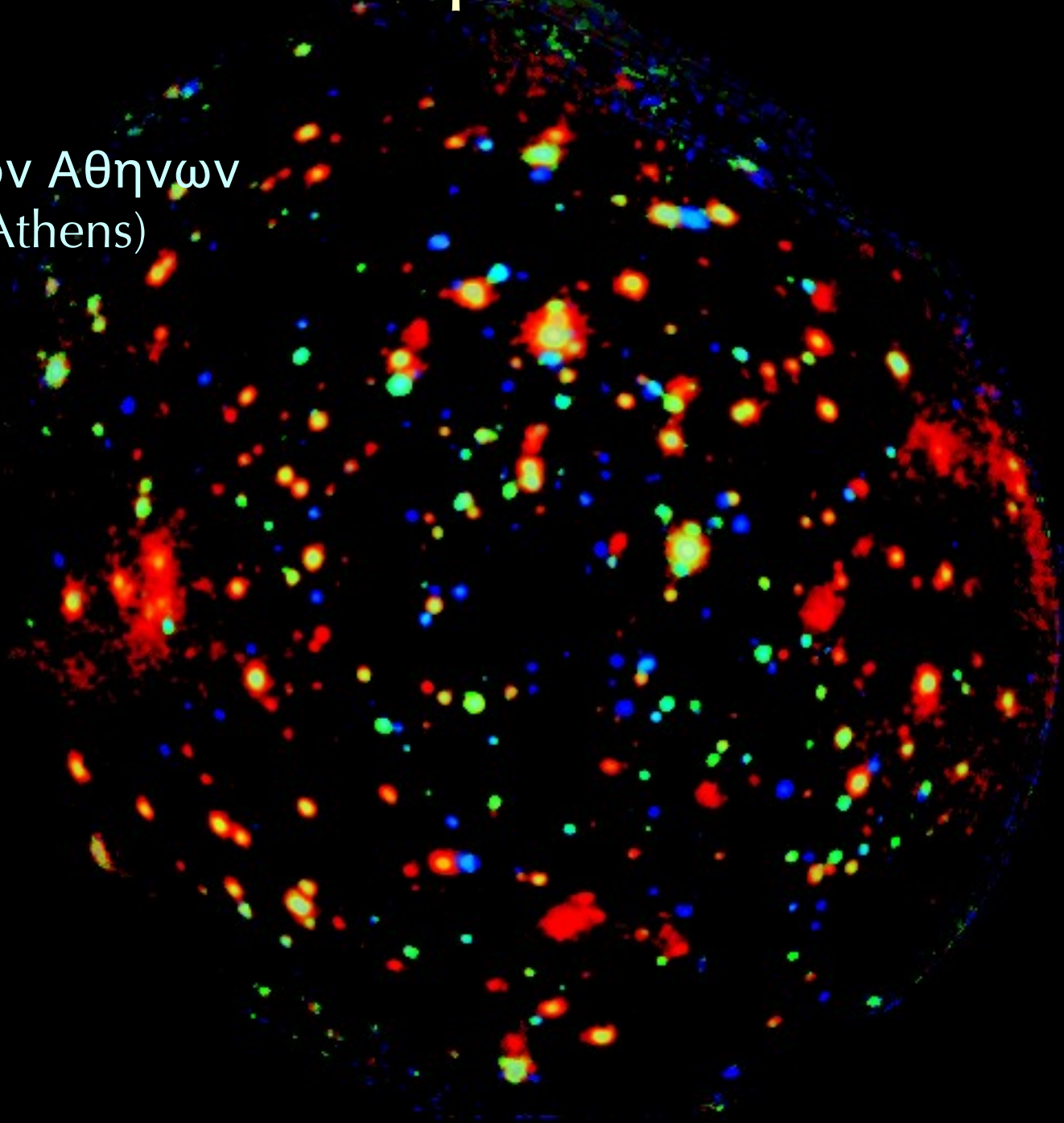
# The XMM-Newton survey in the Chandra Deep Field South

Piero Ranalli,  
Εθνικον Αστεροσκοπειον Αθηνων  
(National Observatory of Athens)



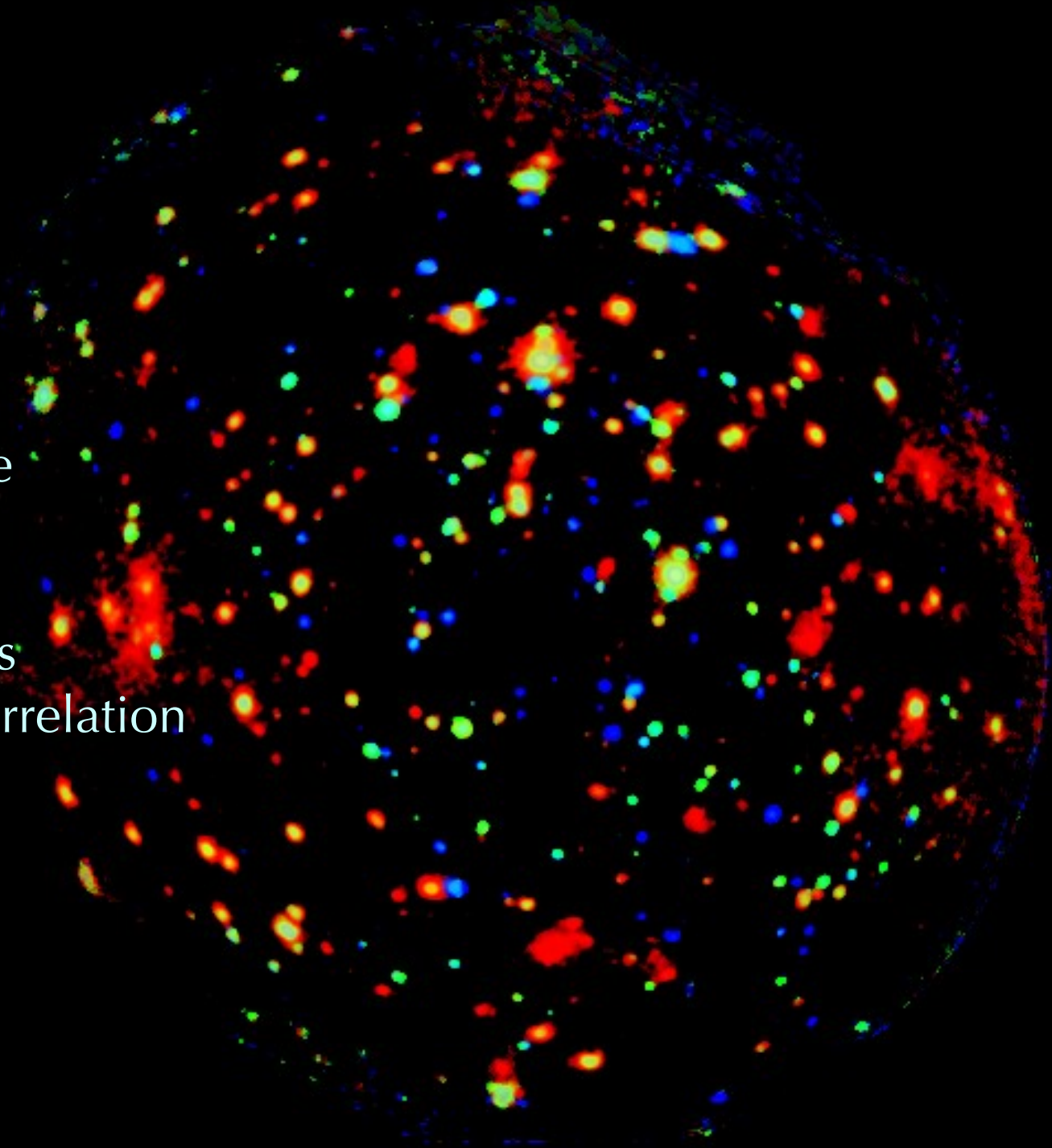
and the XMM-CDFS team

Second XMM-CDFS Meeting,  
31 May-1 June 2012, Cervia



# Talk summary

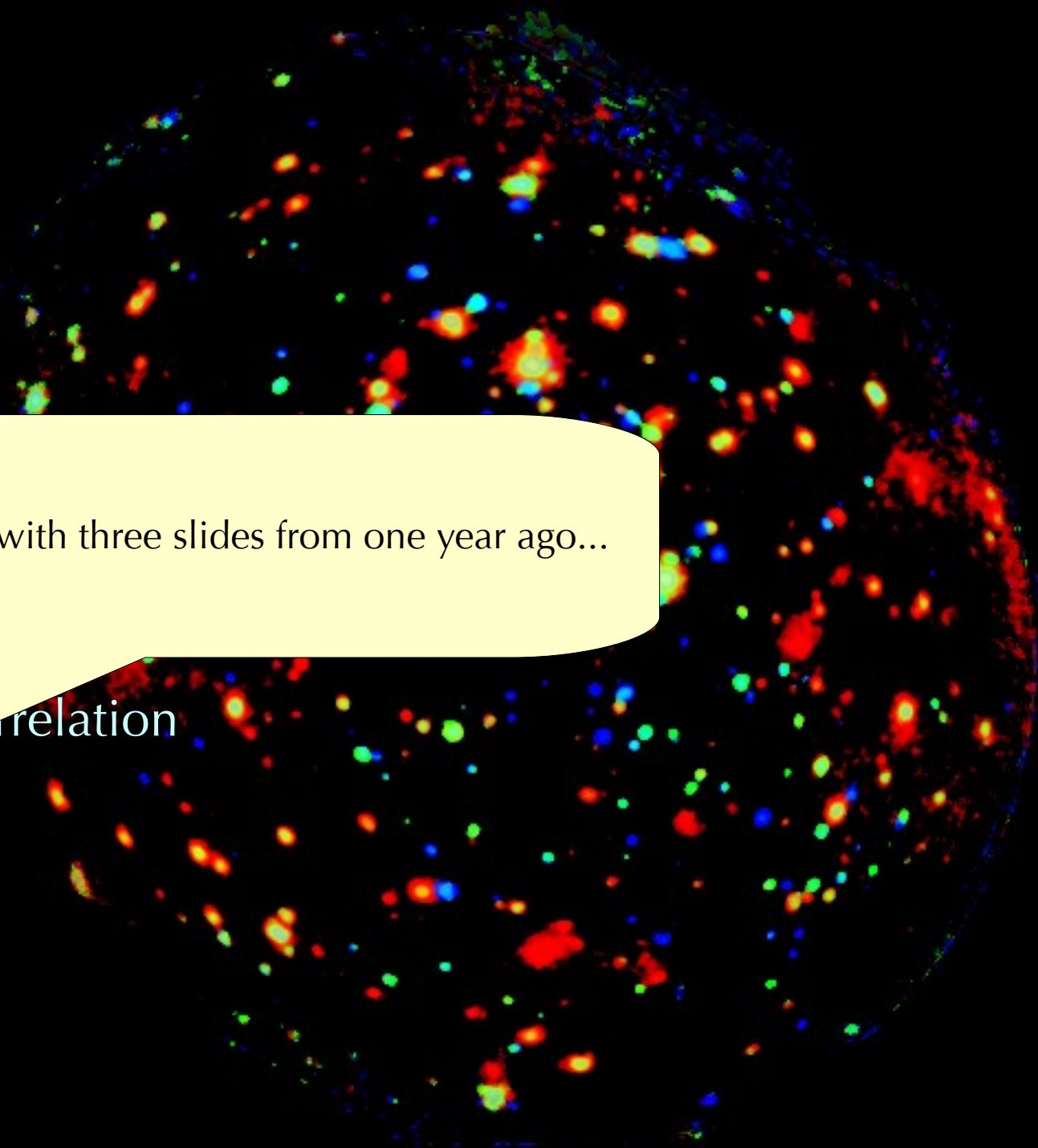
- catalogue status
- the simulator:
  - \* cosmic sources
  - \* soft protons
  - \* particles
  - \* simulator infrastructure and pipeline
- simulations:
  - \* simulated data products
  - \* validation and cross-correlation
  - \* completeness
  - \* reliability
  - \* coverage



# Talk summary

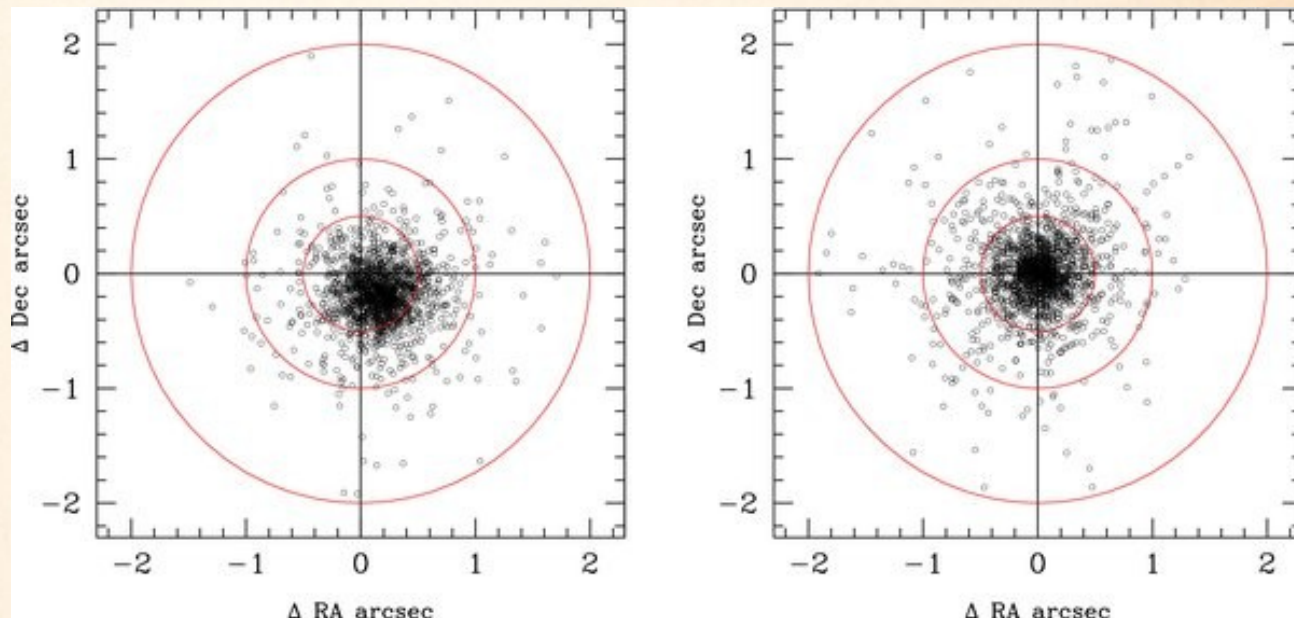
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Let's start with three slides from one year ago...



# Two STAGE Source detection

- ❖ source detection with the combination of PWXDetect and EMLdetect
- ❖ The power of the method is well described by Puccetti+09



This method provides an excellent positioning of the sources because PWXD works on events and is not affected by the binning

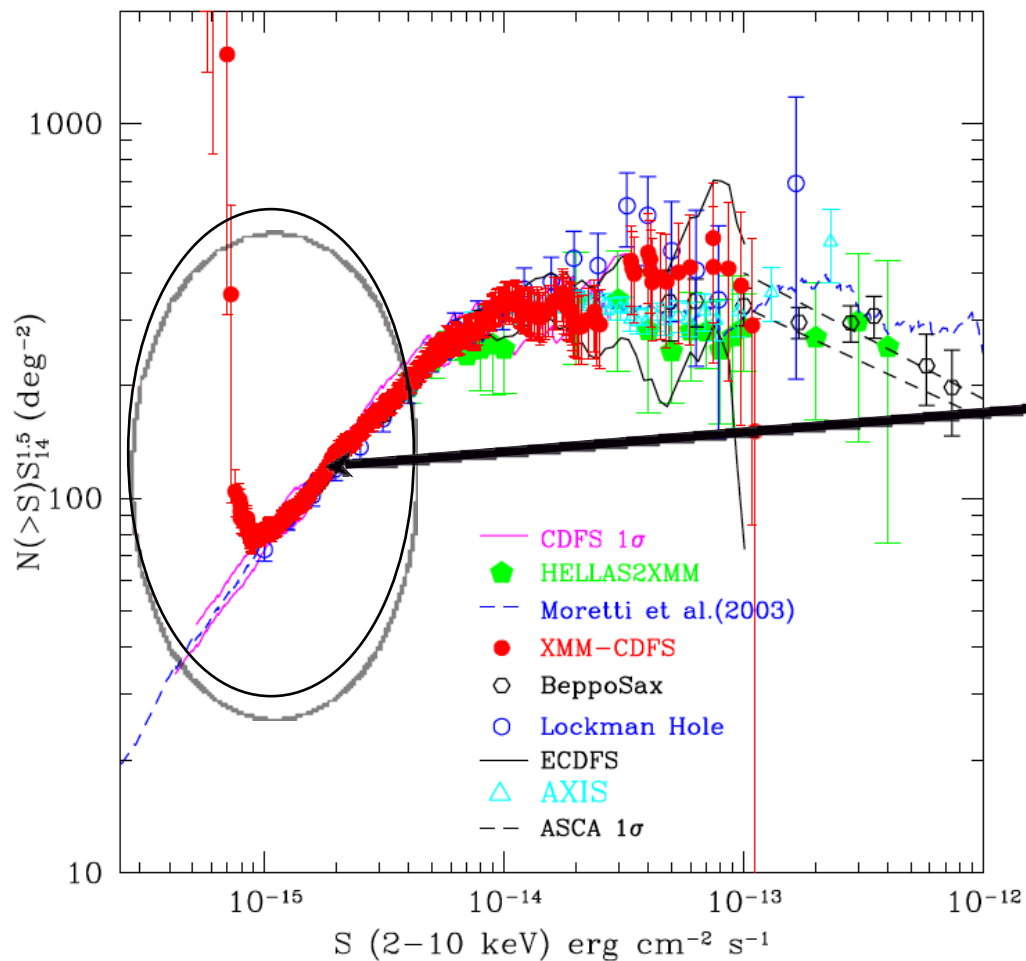
- ❖ EMLdetect provides the best possible photometry for point-source
- ❖ We first run a low threshold run of PWD to provide an input list for EML detect
- ❖ PWD detects sources and at the same time performs a fit to the background with several possibility of  $\sigma$  clipping.
- ❖ The best combination was found to be  $4\sigma$  for the source detection and  $3\sigma$  for the background

Also:  
Check with aperture photometry

- catalogues (still preliminary):

- \* 2-10 keV, cut at ~~4 sigma: 411 sources~~  $4\sigma$  AND  $ML \geq 4.6$ : 337 sources
- \* 2-10 keV, cut at 10 sigma and 1 Ms exposure: 130 sources  
("spectral catalogue")
- \* 5-10 keV, cut at 5 sigma: 92 sources

# Number counts and simulations



Faint end very sensitive to observational biases

simulations needed to derive reliable coverage

Method:  
repeat detections  
on mock-up surveys

# The XMM-CDFS simulator: overview

Reproduces cosmic sources + background

Background components:

- unresolved X-ray sources
- particle background (electronic noise)
- residual soft protons
- solar wind charge exchange

Each one with its own spatial distribution

# The XMM-CDFS simulator: overview

Reproduces cosmic sources + background

Background components:

- unresolved X-ray sources
- particle background (electronic noise)
- residual soft protons
- ~~= solar wind charge exchange => negligible at  $E > 2$  keV~~

Each one with its own spatial distribution



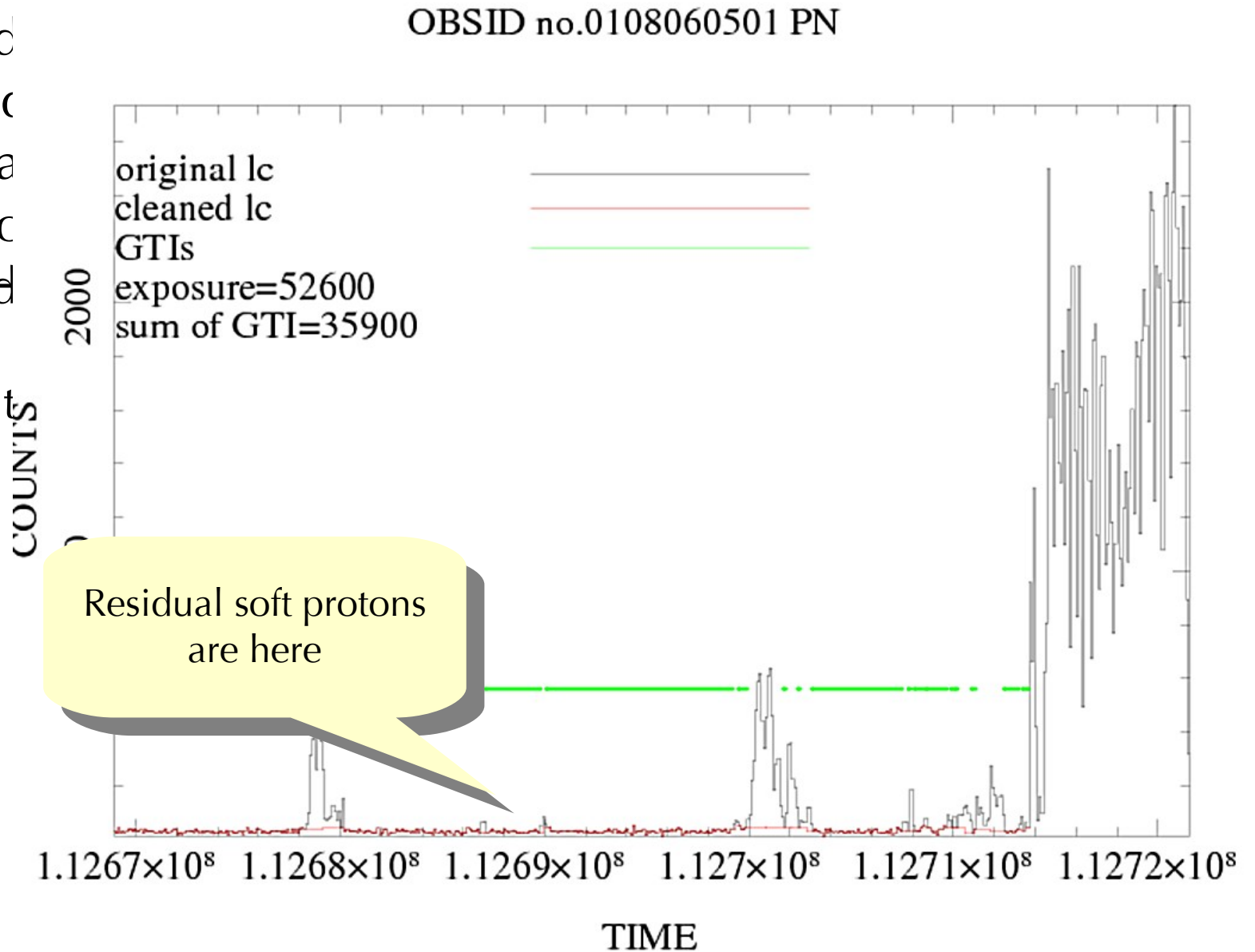
# The XMM-CDFS simulator: overview

Reproduces cosmic sources + background

Background

- unresolved
- particle background
- residual solar wind
- solar wind

Each one with



# The XMM-CDFS simulator: overview

Background components (surface brightnesses):

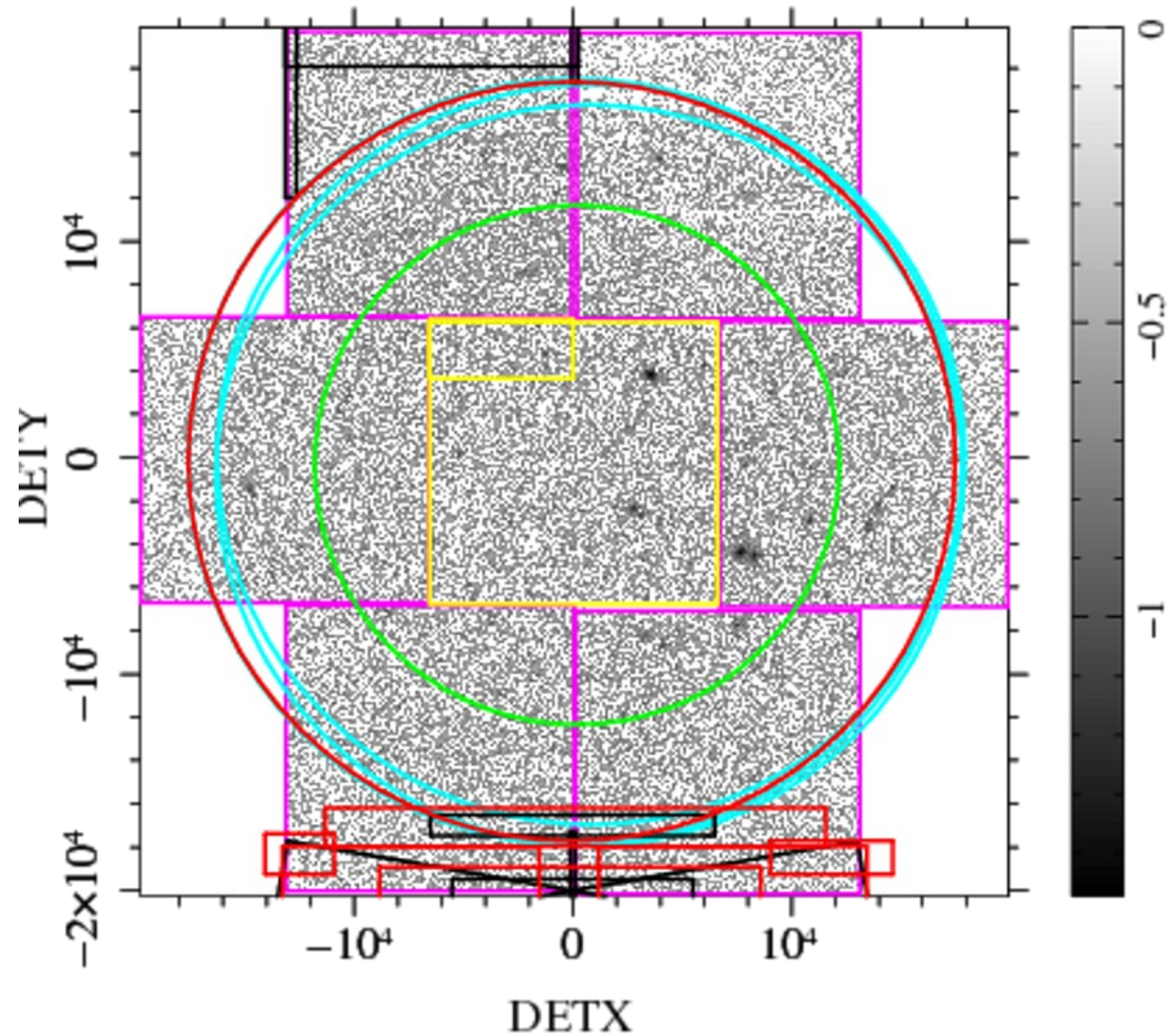
$$\Sigma_{\text{FOV}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

# The XMM-CDFS simulator: overview

Background components (surface brightnesses):

$$\Sigma_{\text{FOV}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

$$\Sigma_{\text{CORNER}} = k \Sigma_{\text{PART}}$$



# The XMM-CDFS simulator: overview

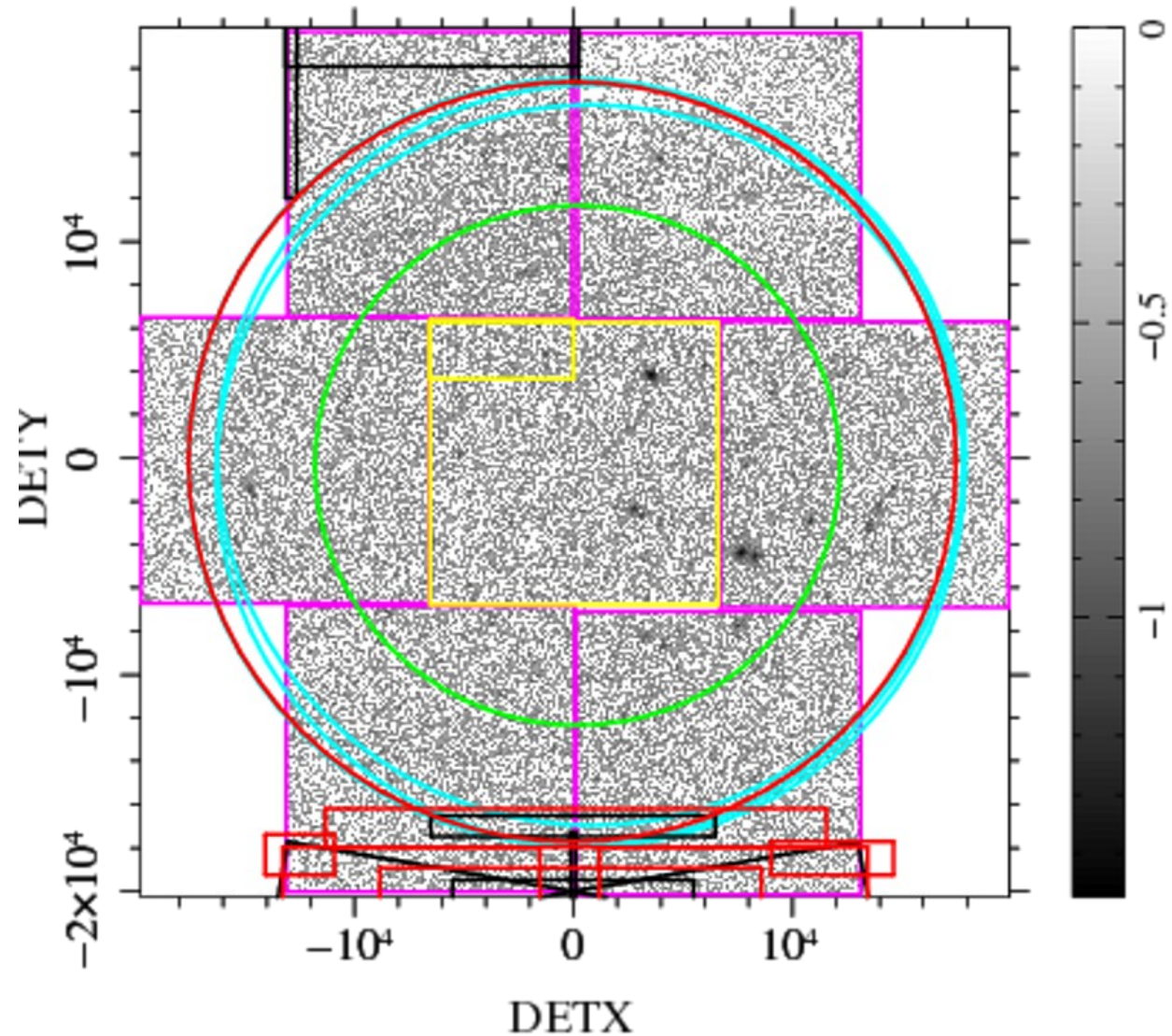
Background components (surface bright

To estimate the  $k$ , let's close the lid of the telescope:  
**(Filter Wheel: Closed)**

$$\Sigma_{\text{FOV}, \text{FWC}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

$$\Sigma_{\text{CORNER}, \text{FWC}} = k \Sigma_{\text{PART}}$$

Filter Wheel Closed (FWC) data are available in the ESAS CALDB

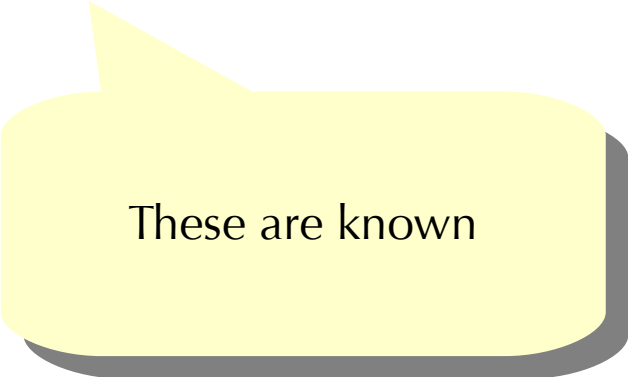


# The XMM-CDFS simulator: overview

Background components (surface brightnesses):

$$\Sigma_{\text{FOV}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

$$\Sigma_{\text{CORNER}} = k \Sigma_{\text{PART}}$$



These are known

# The XMM-CDFS simulator: overview

Background components (surface brightnesses):

$$\Sigma_{\text{FOV}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

$$\Sigma_{\text{CORNER}} = k \Sigma_{\text{PART}}$$

$\Sigma_{\text{PART}}$  is obtained

These are known

# The XMM-CDFS simulator: overview

Background components (surface brightnesses):

$$\Sigma_{\text{FOV}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

$\Sigma_{\text{COSM}}$  is given by the integration of the LogN-LogS

$$\Sigma_{\text{CORNER}} = k \Sigma_{\text{PART}}$$

$\Sigma_{\text{PART}}$  is obtained

These are known

# The XMM-CDFS simulator: overview

Background components (surface brightnesses):

$$\Sigma_{\text{FOV}} = \Sigma_{\text{PART}} + \Sigma_{\text{SP}} + \Sigma_{\text{COSM}}$$

$\Sigma_{\text{COSM}}$  is given by the integration of the LogN-LogS

$$\Sigma_{\text{CORNER}} = k \Sigma_{\text{PART}}$$

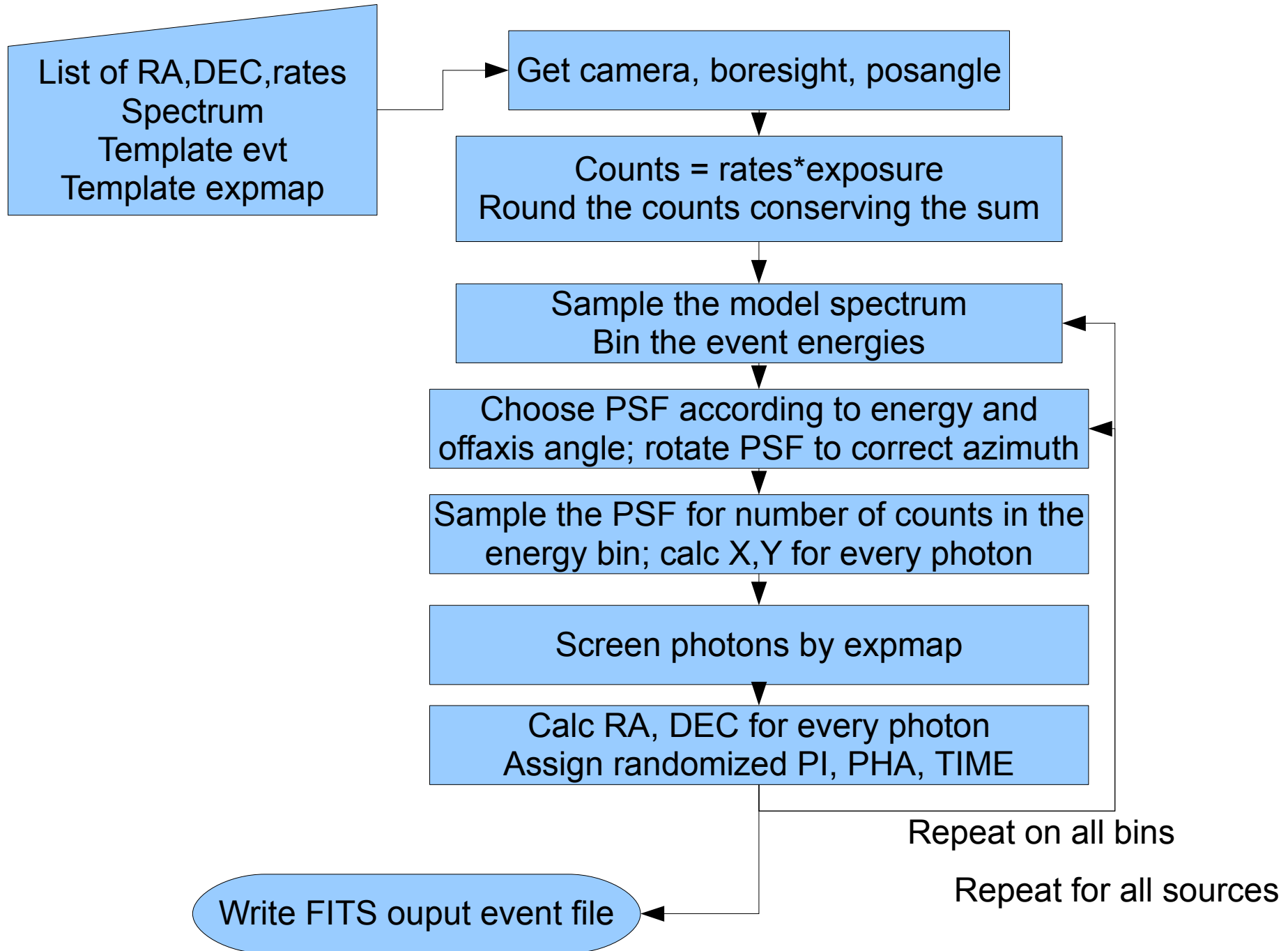
Thus  $\Sigma_{\text{SP}}$  is obtained

$\Sigma_{\text{PART}}$  is obtained

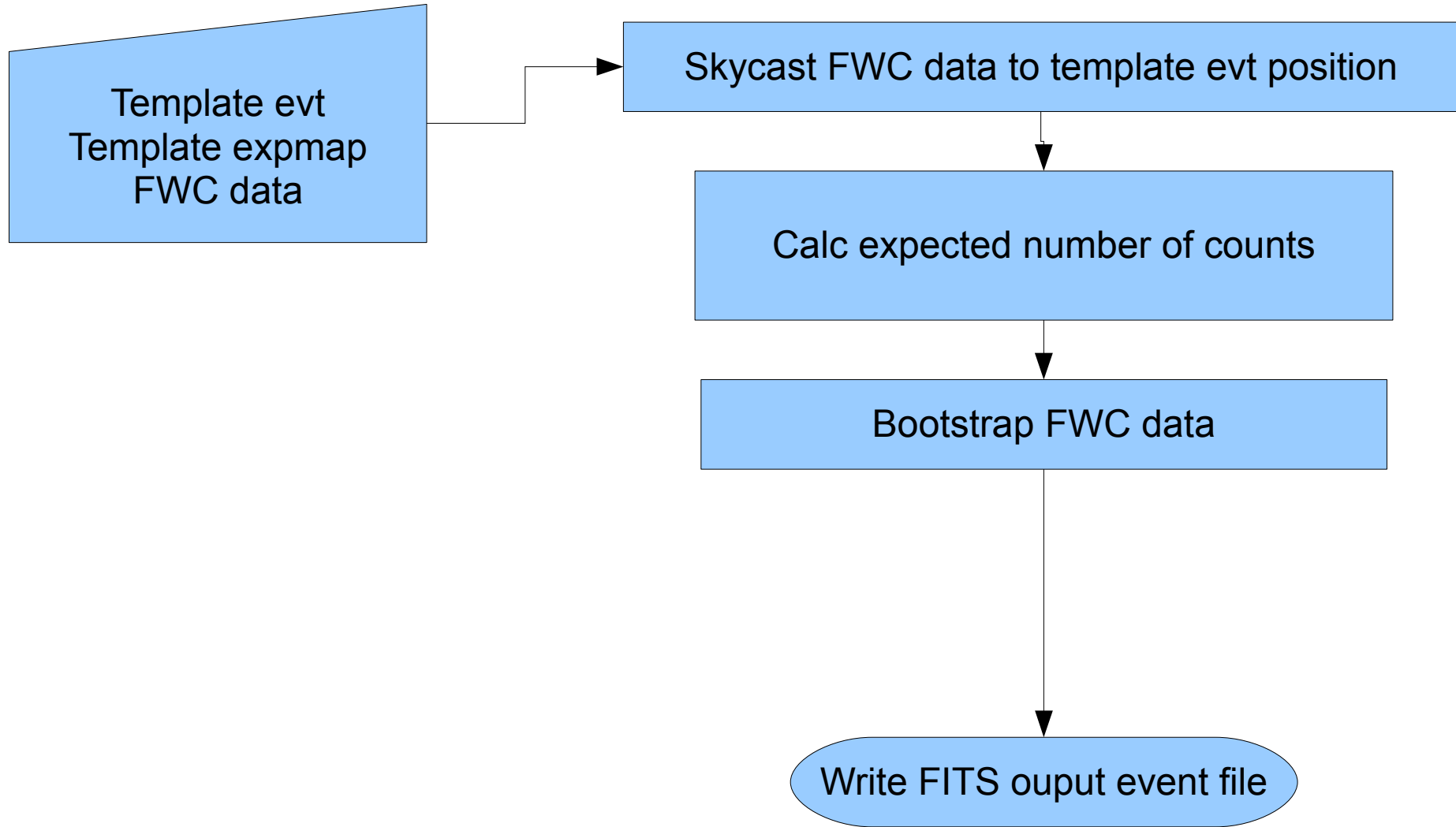
These are known



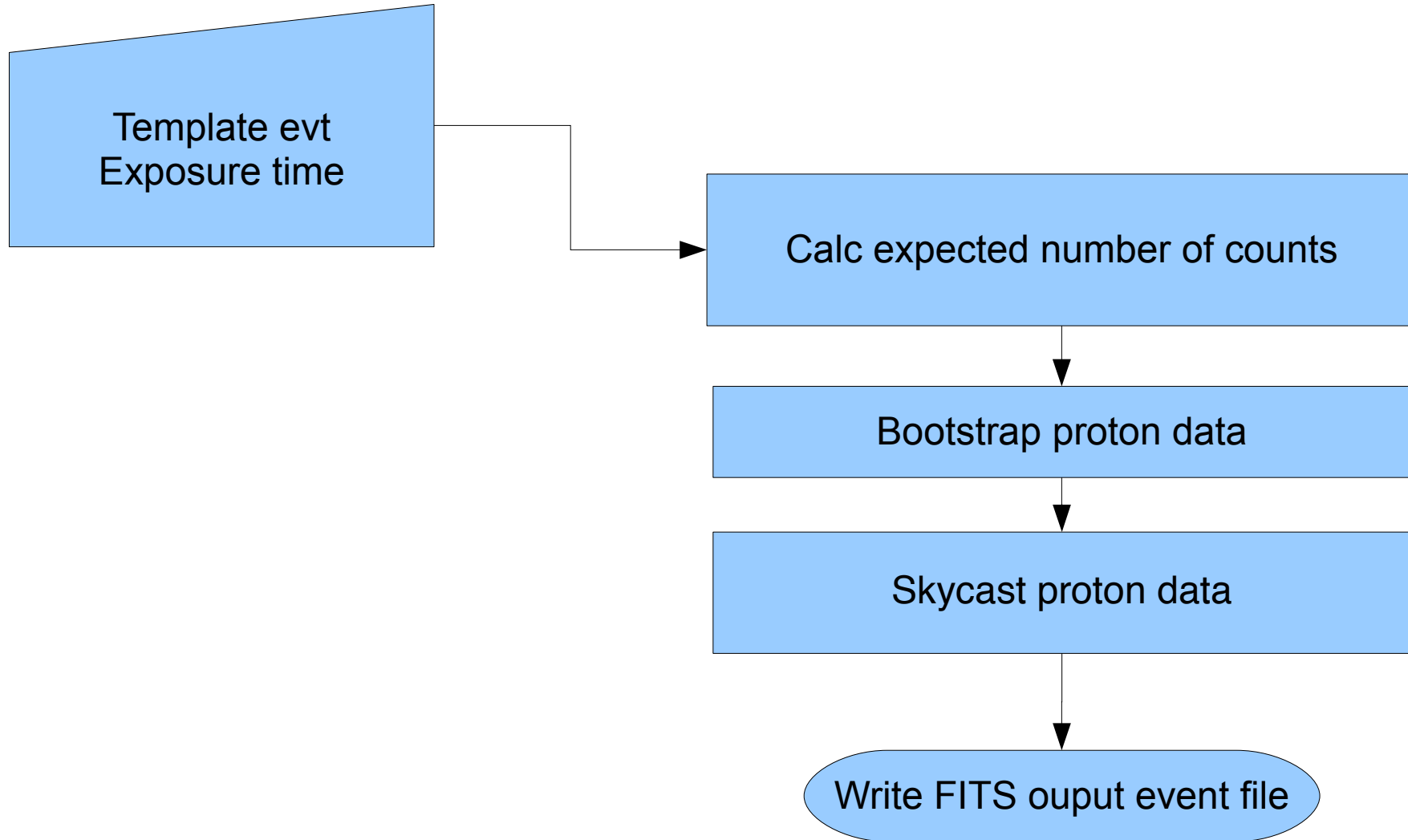
# The XMM-CDFS simulator (sources)



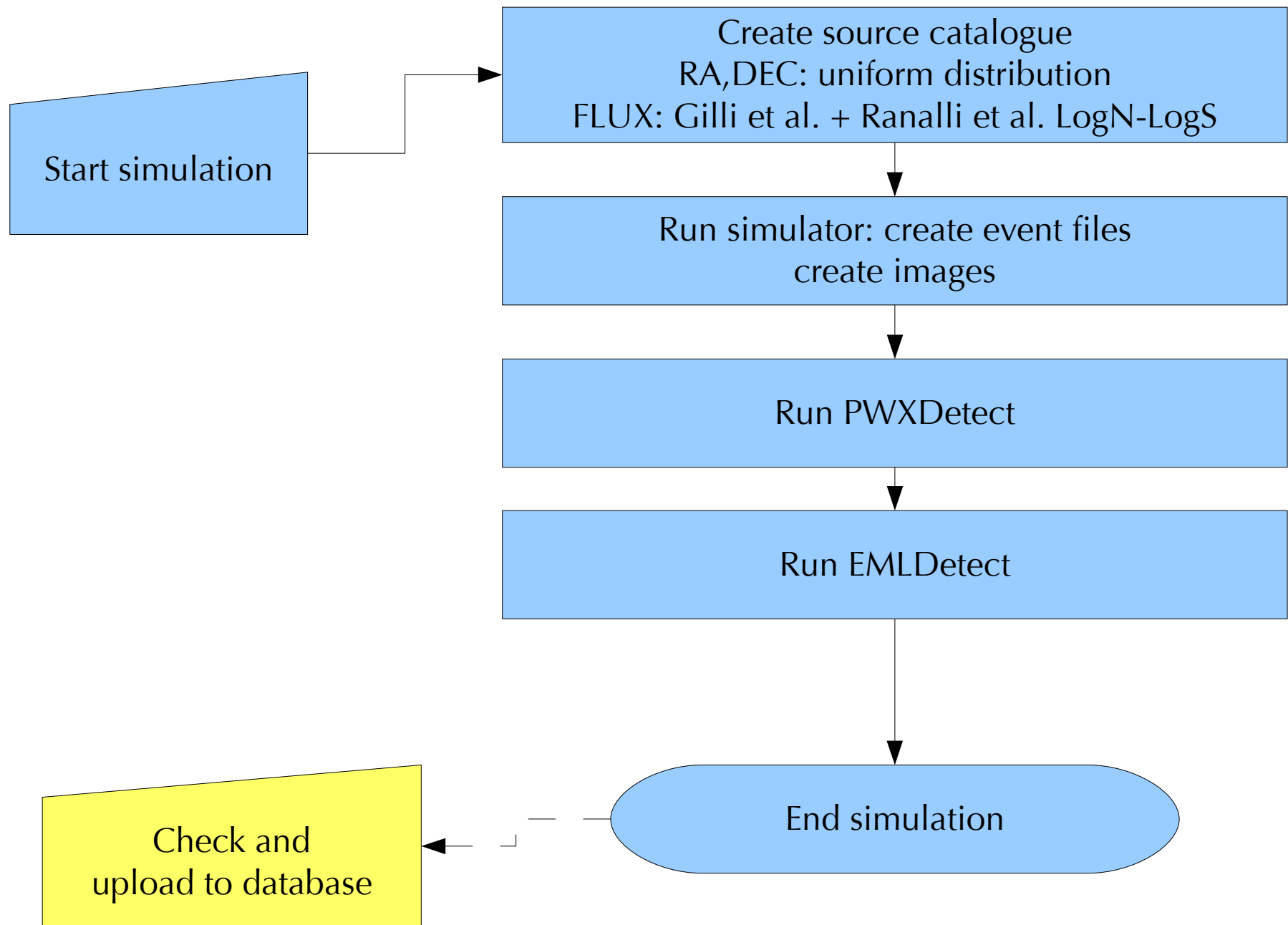
# The XMM-CDFS simulator (particles)



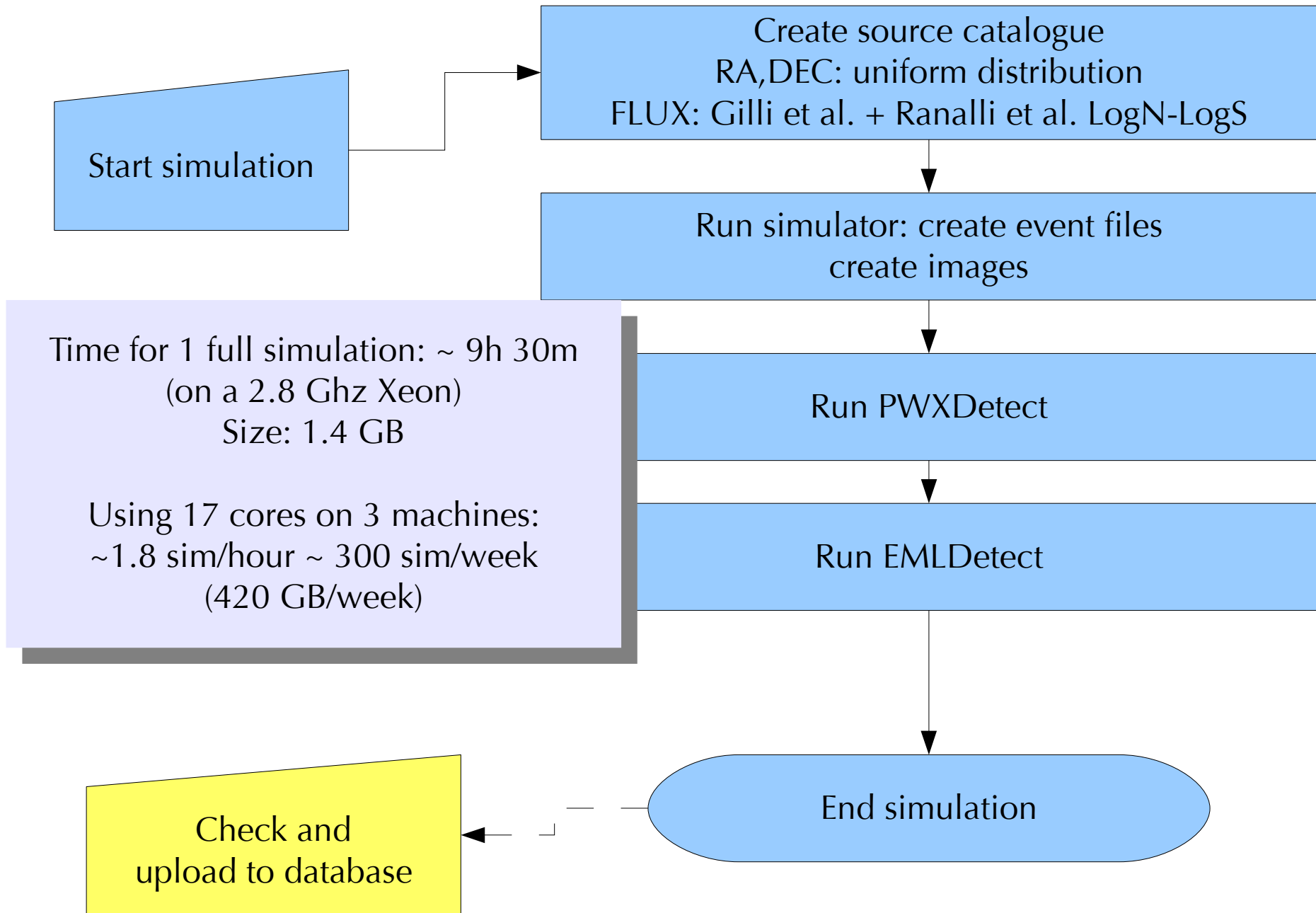
# The XMM-CDFS simulator (residual soft protons)



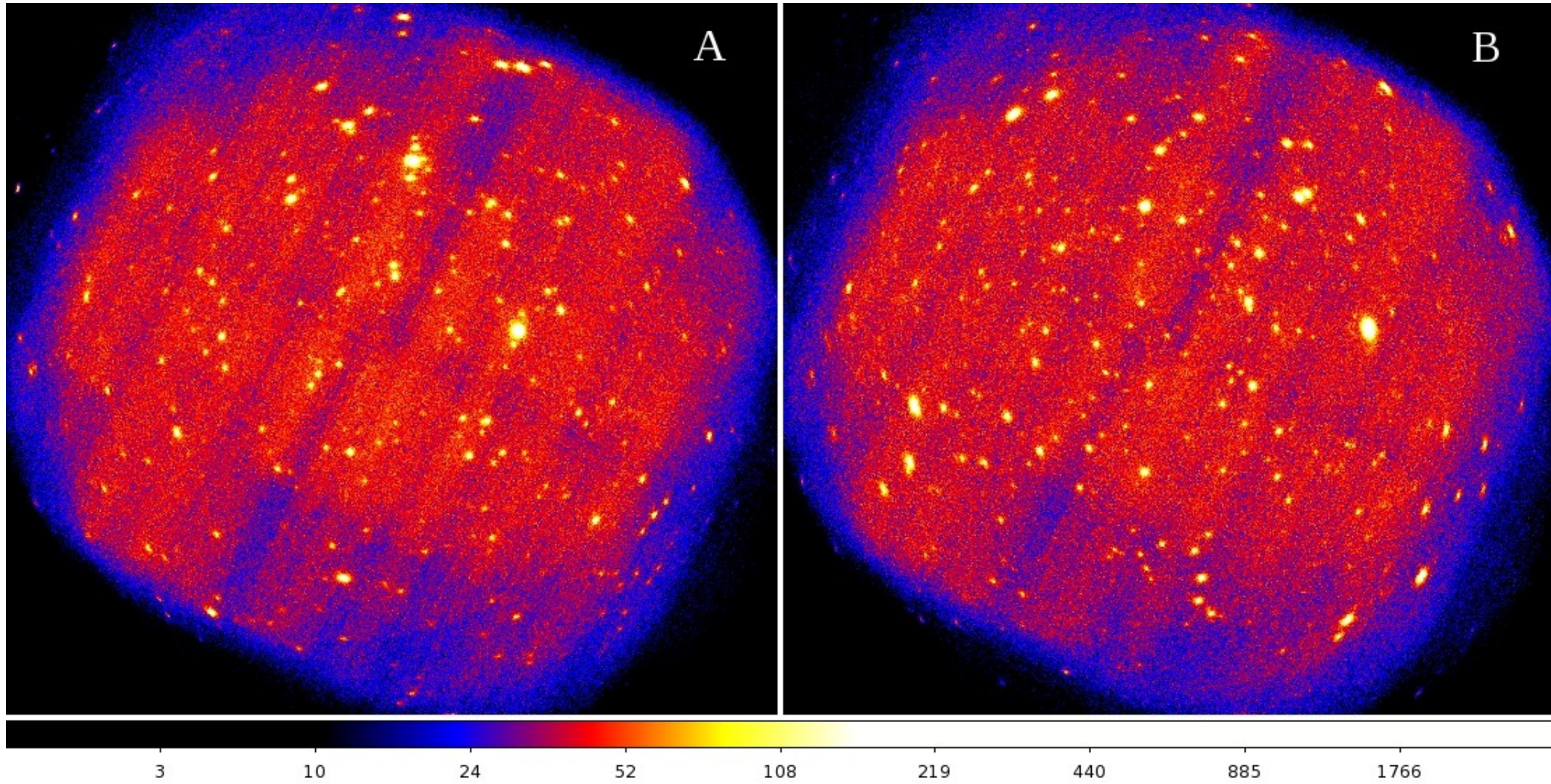
# The XMM-CDFS simulator pipeline



# The XMM-CDFS simulator pipeline



# Simulated vs. real XMM-CDFS



The background level distribution is reproduced with a 7% error

## Simulated data products:

- INPUT catalogue (generated from LogN-LogS)
- PWXDected-ed catalogue ( $3\sigma$ - $4\sigma$  thresholds)
- EMLDetect-ed catalogue ( $ML \geq 4.6$ )

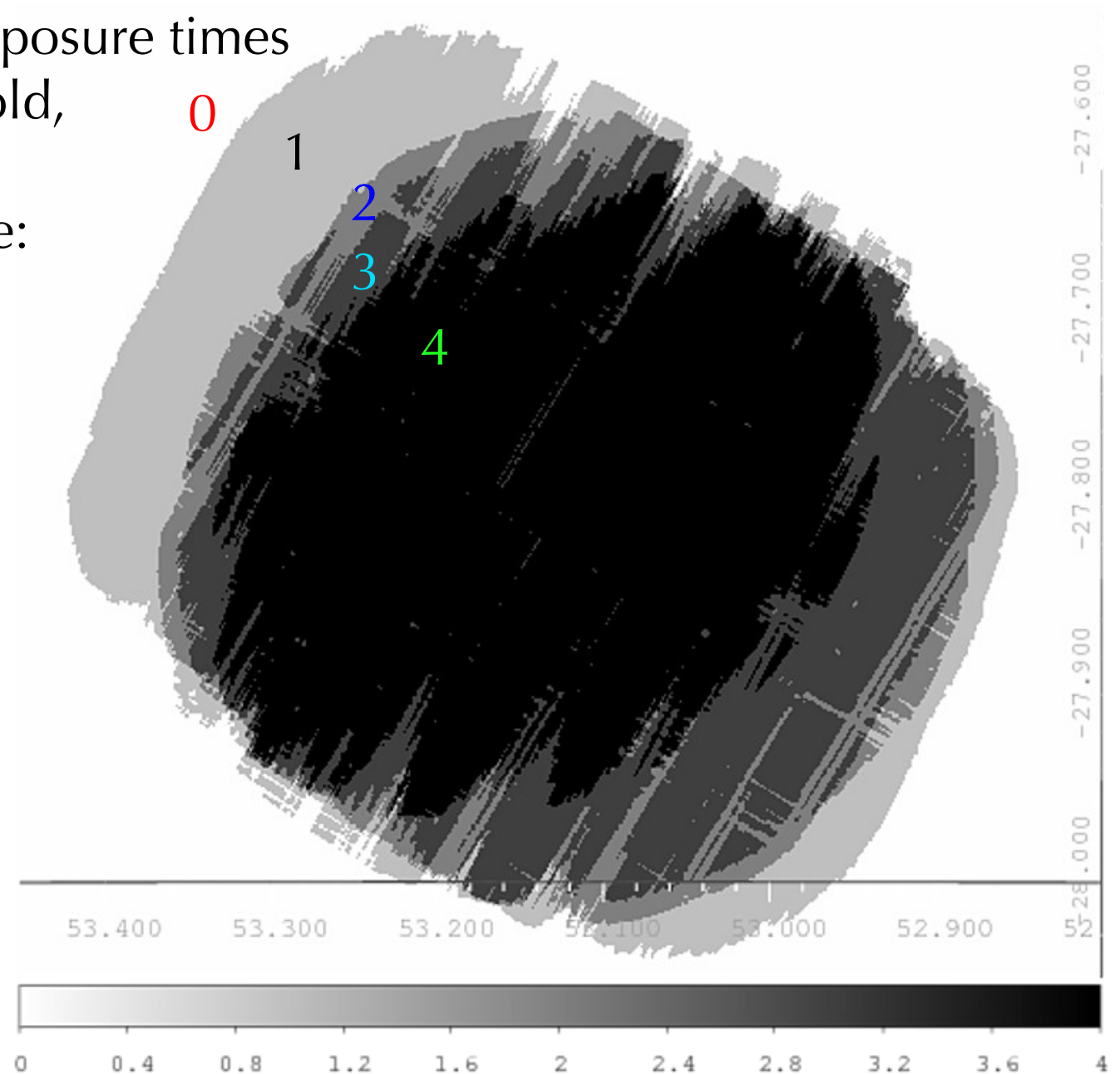
## Simulated data products:

- INPUT catalogue (generated from LogN-LogS) ~500,000 sources
- PWXDected-ed catalogue ( $3\sigma$ - $4\sigma$  thresholds) 338,446 sources
- EMLDetect-ed catalogue ( $ML \geq 4.6$ ) 139,047 sources  
from 389 simulations

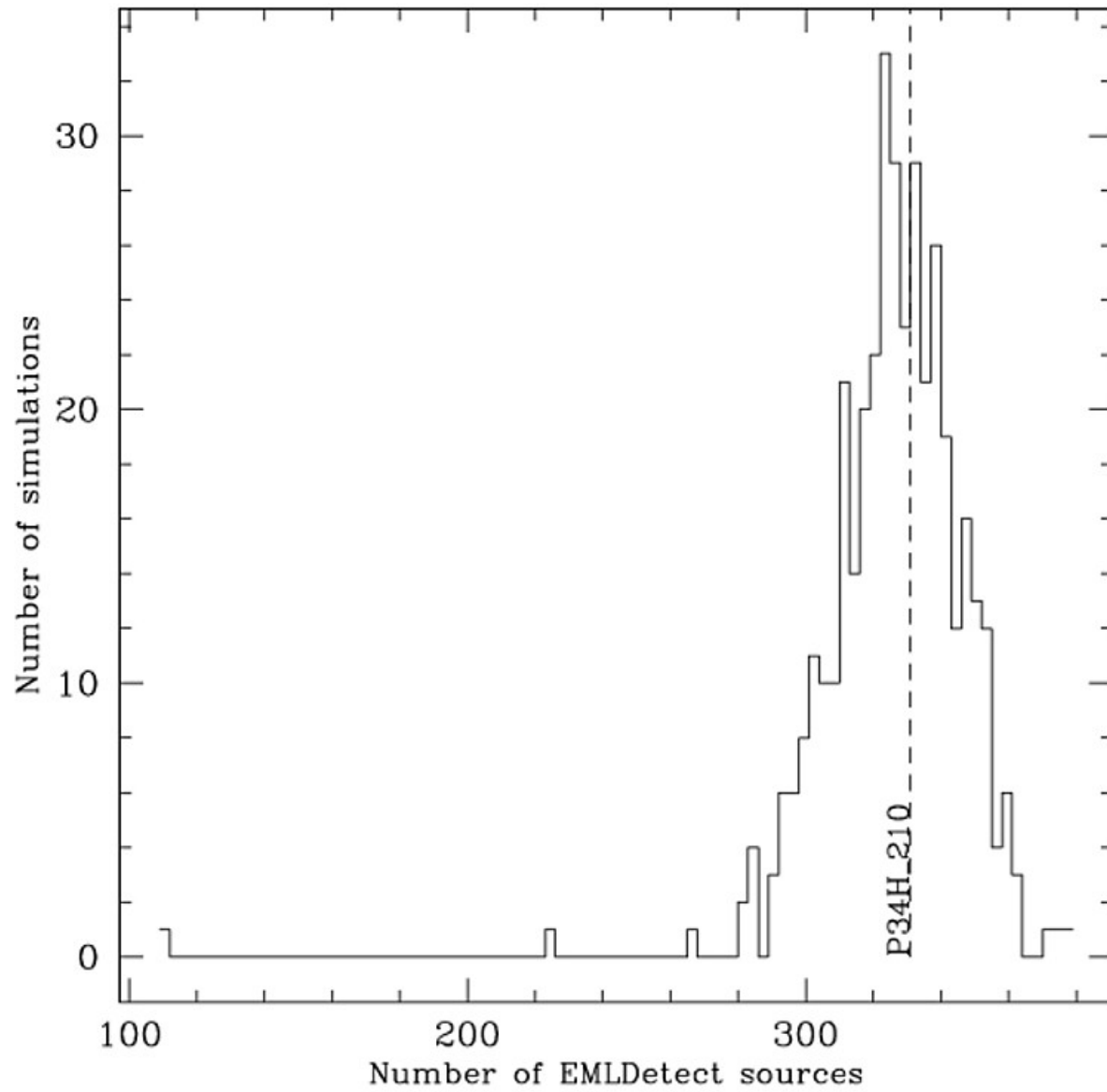


# Catalogue screening: the *detector mask*

Remove sources with exposure times below minimum threshold, just like we did for the P34H\_210 catalogue: retain only sources with  $\text{detmask} \geq 1$



# EMLDetect-ed sources



## Simulated data products:

- INPUT catalogue (generated from LogN-LogS)
- PWXDected-ed catalogue
- EMLDetect-ed catalogue (subset of PWXD)

## Cross-correlations:

INPUT and EMLD => *recovered* sources

INPUT and not EMLD => *missed* sources

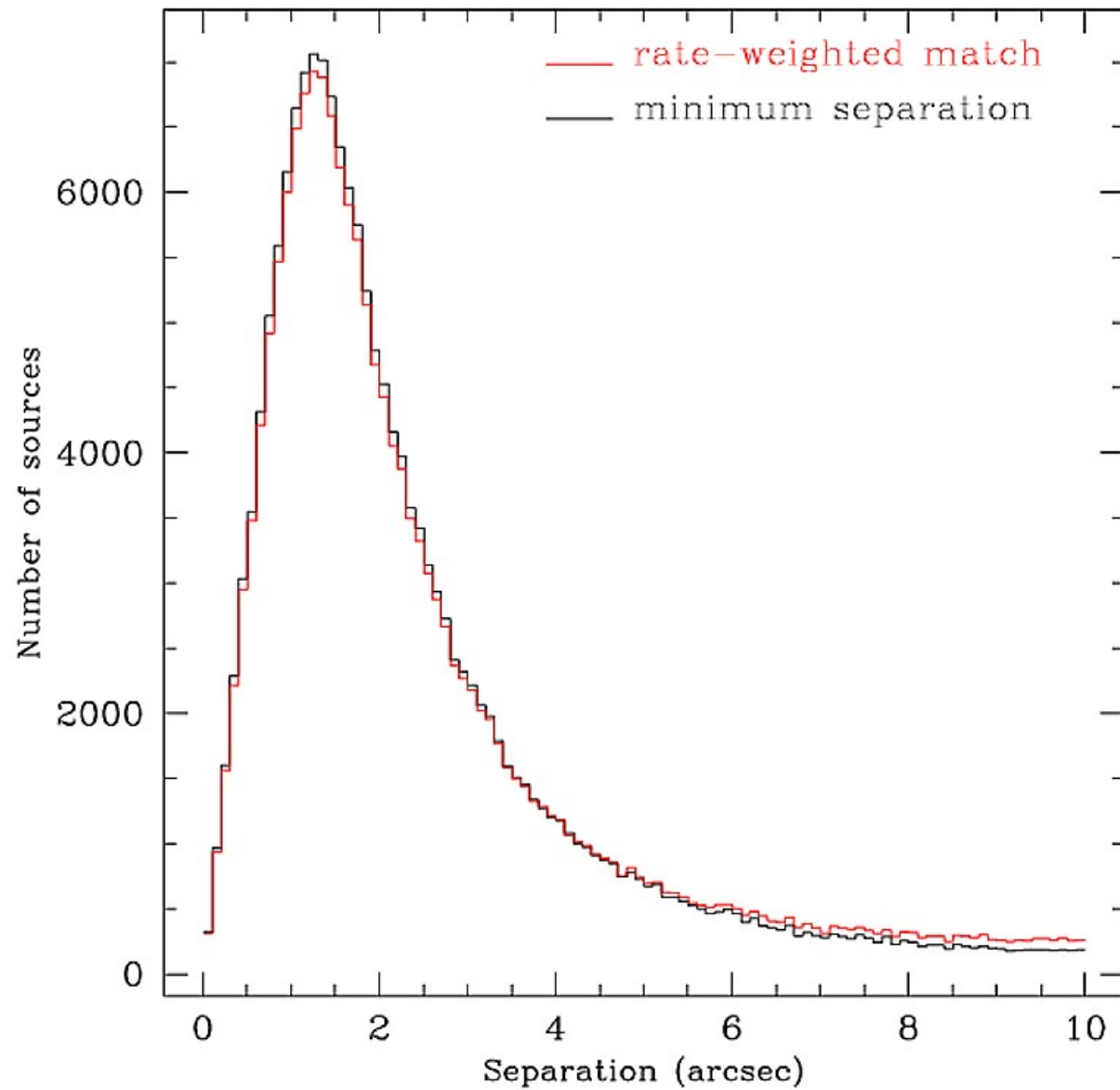
EMLD and not INPUT => *fake* sources

## Cross-correlation methods:

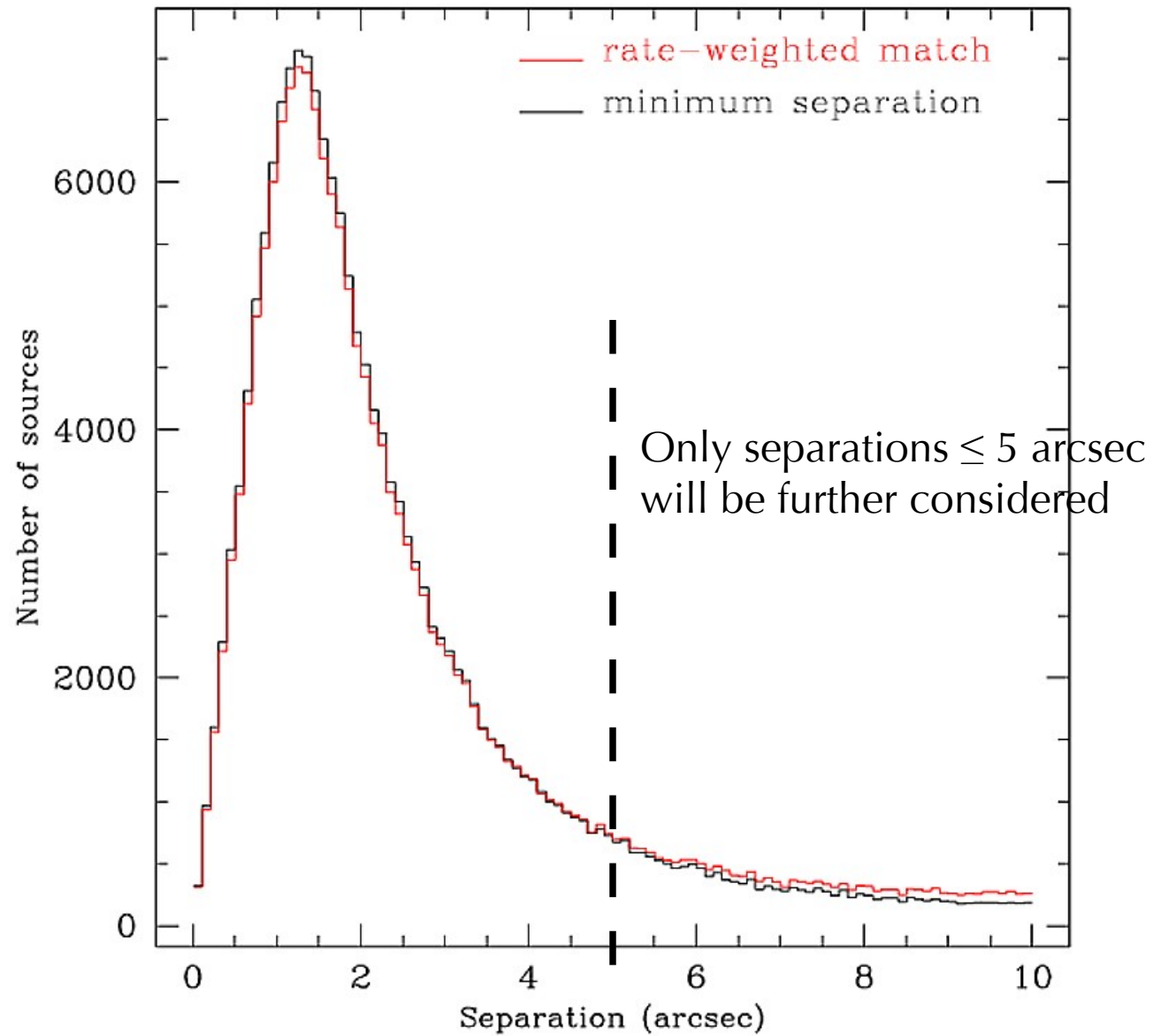
- nearest source
- minimum  $\chi^2$ , defined as:

$$\chi^2 = (\Delta RA / RA\_err)^2 + (\Delta DEC / DEC\_err)^2 + (\Delta S / S\_err)^2$$

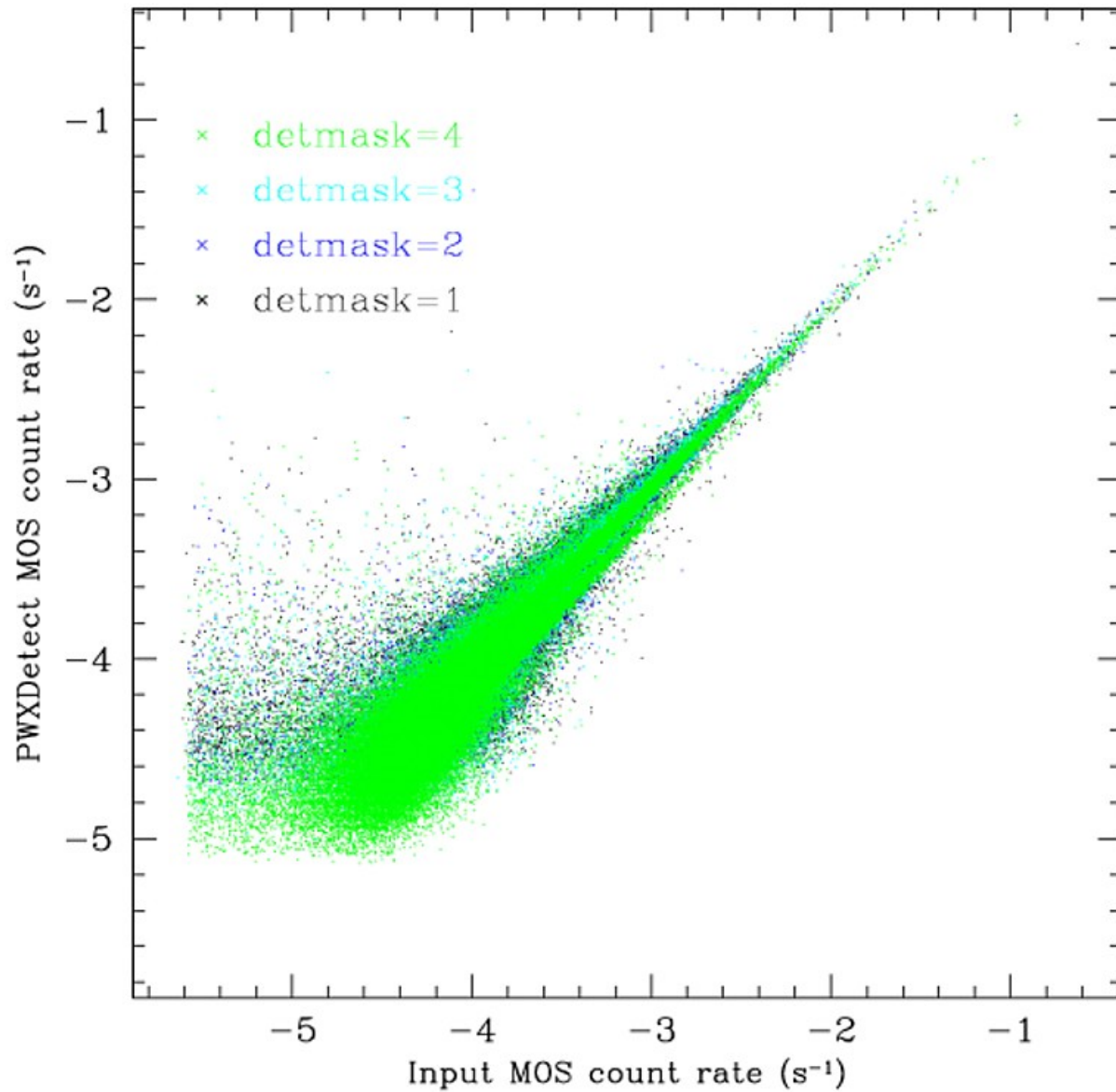
## Separation between input and pwxd souces



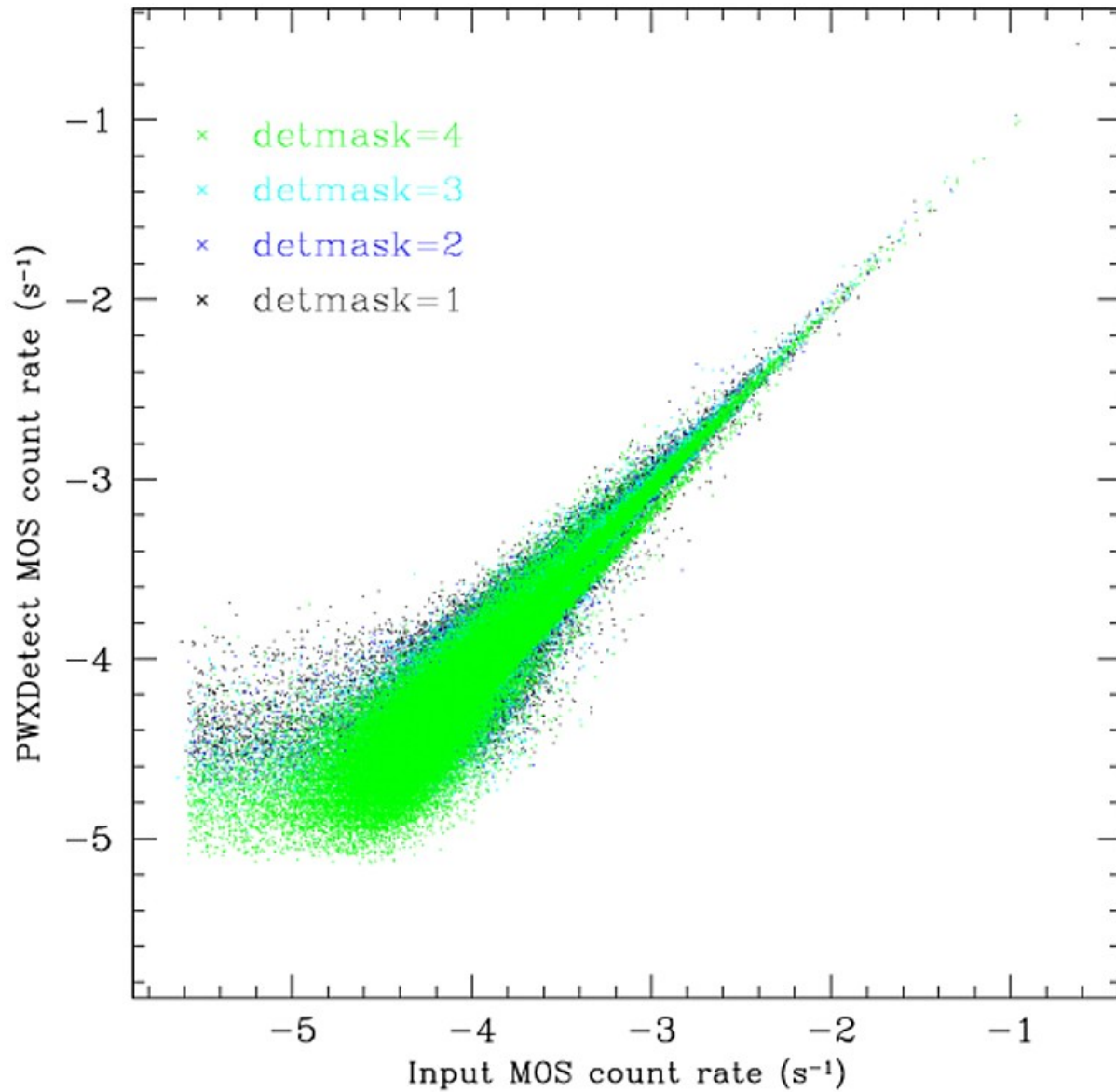
# Separation between input and pwxd souces



INPUT vs. PWXD rates (151121 sources from 389 simulations)  
match: nearest source

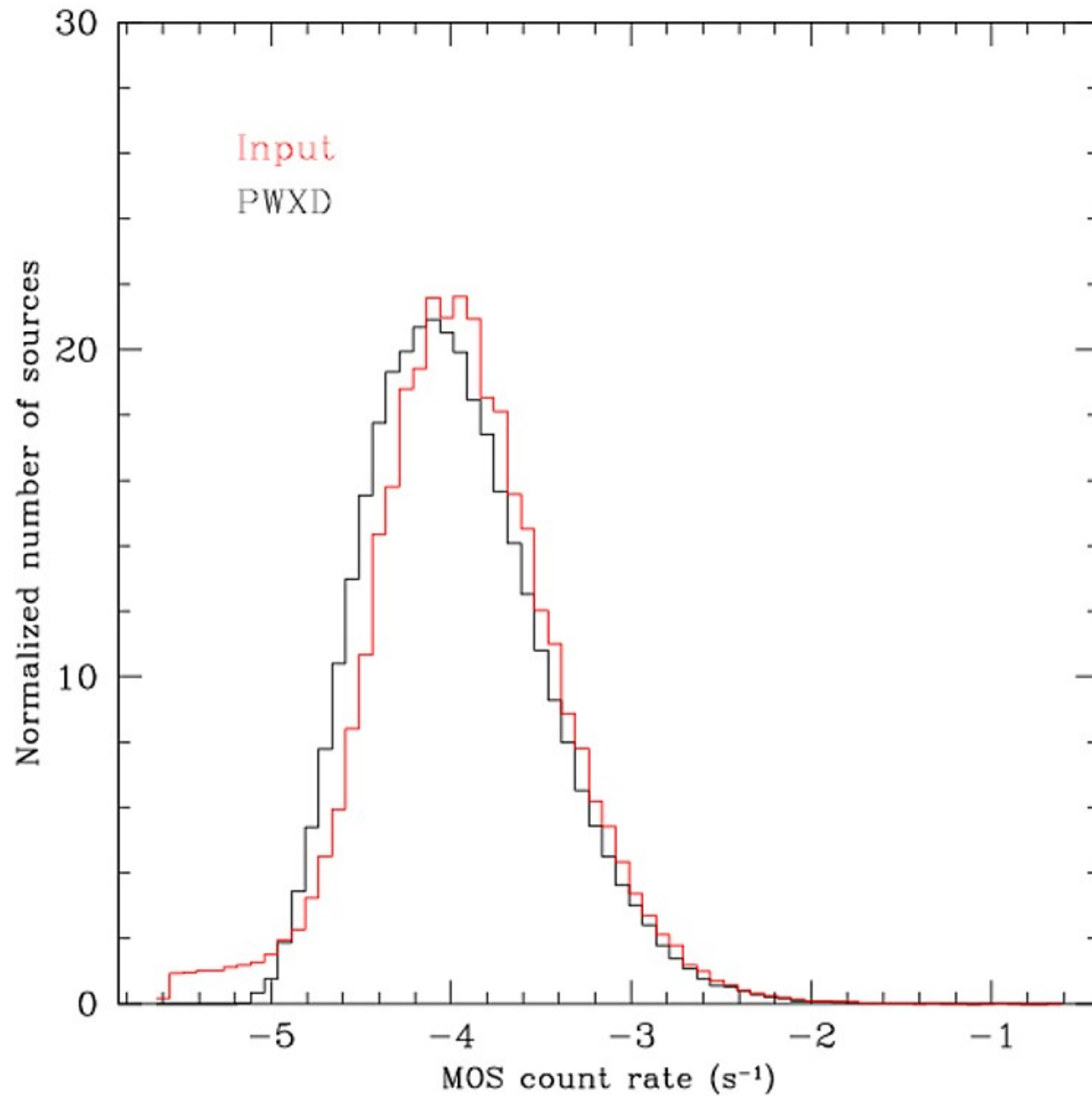


INPUT vs. PWXD rates (151121 sources from 389 simulations)  
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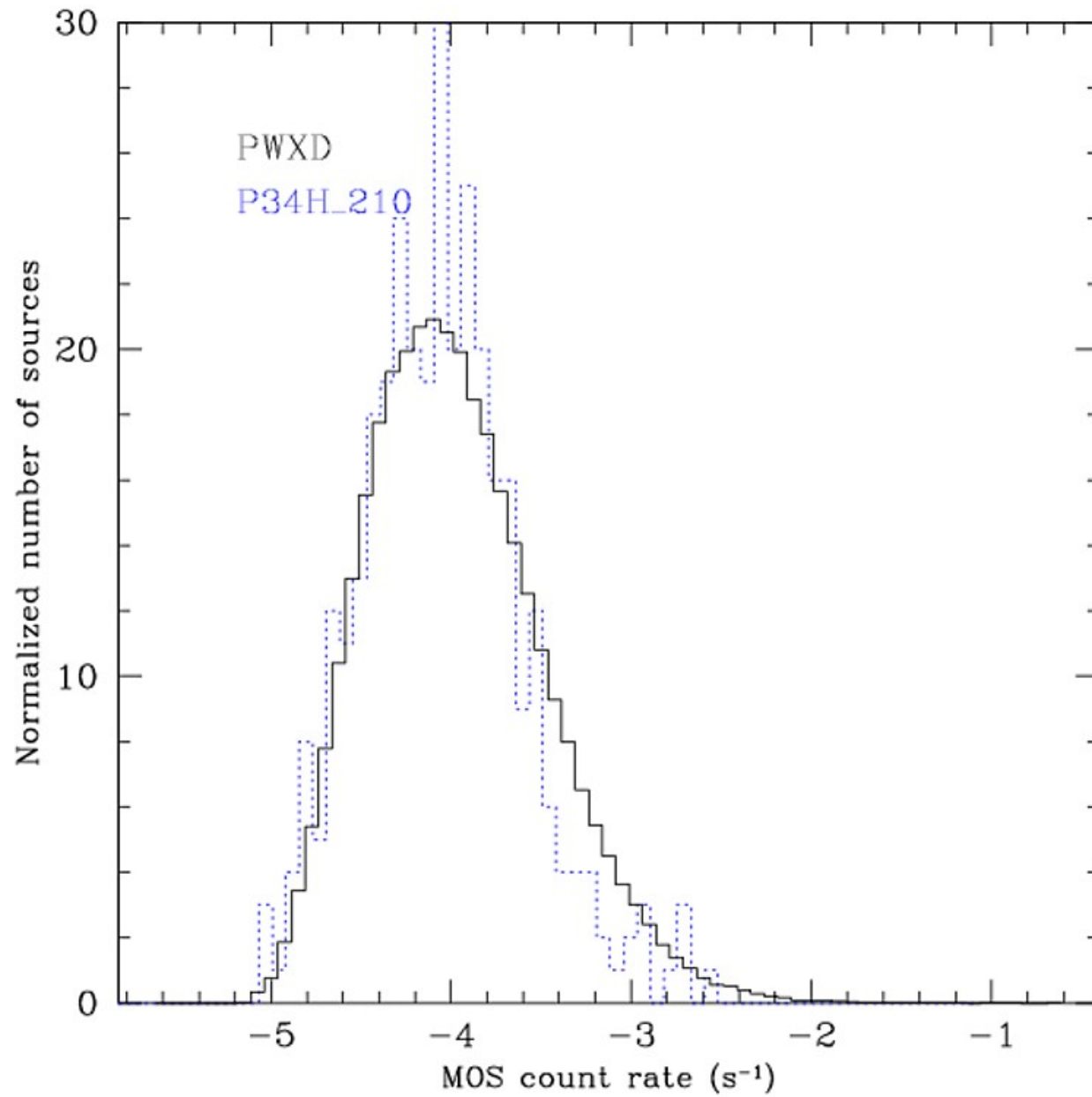
# INPUT vs. PWXD rates (151121 sources from 389 simulations) match: minimum $\chi^2$

PWXD slightly  
underestimates the  
count rates

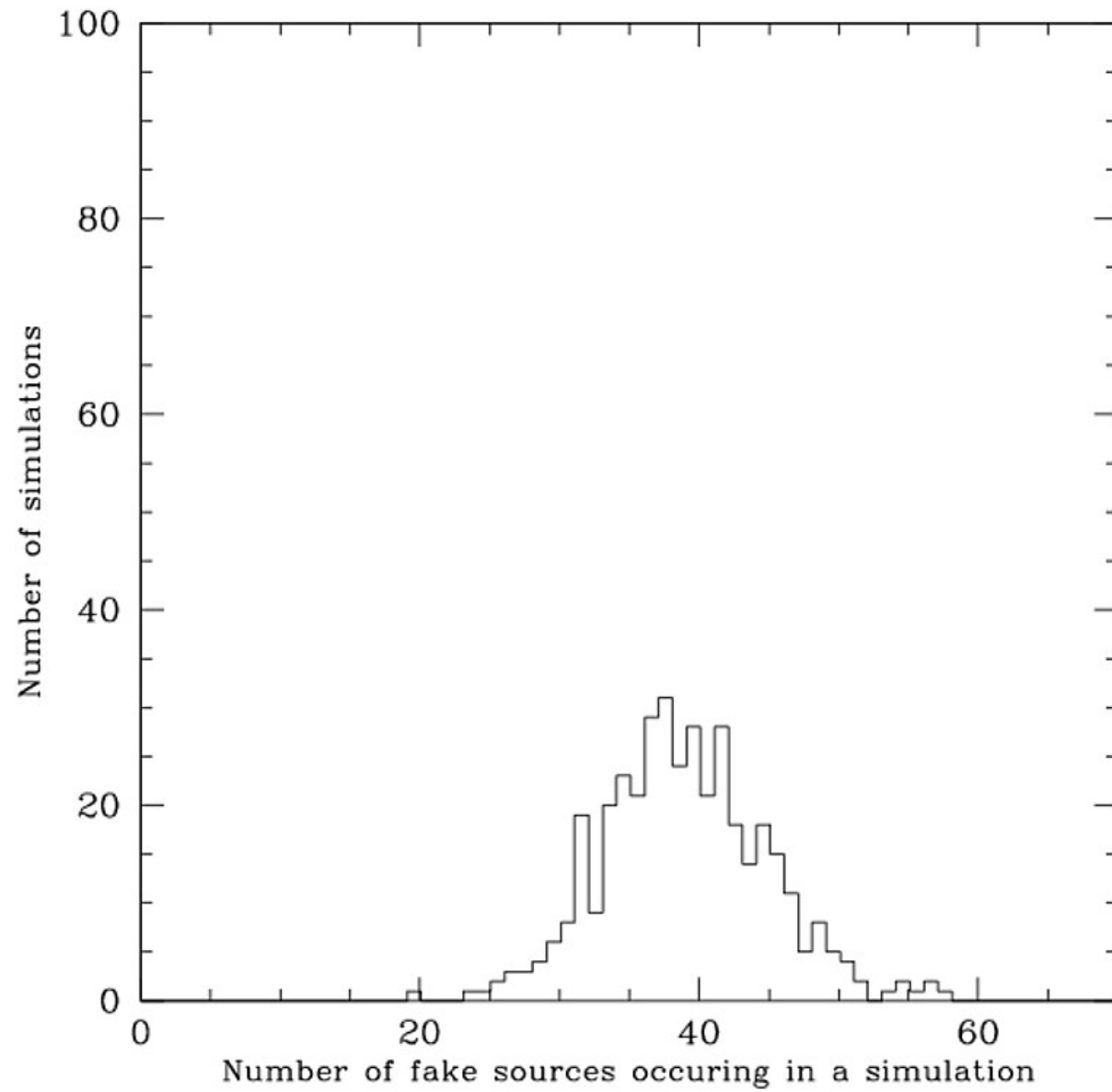




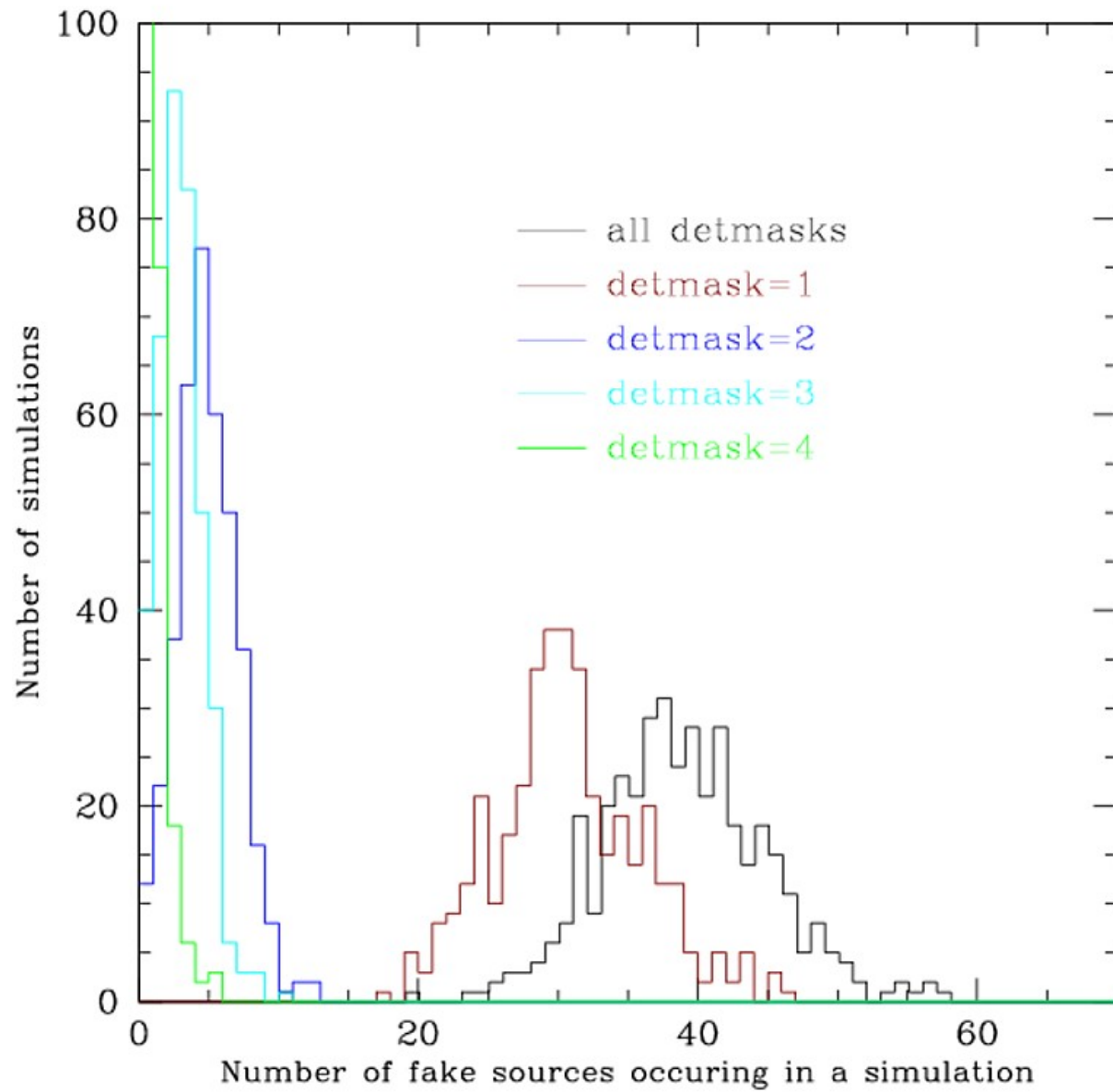
# P34H vs. PWXD rates



## Fake sources

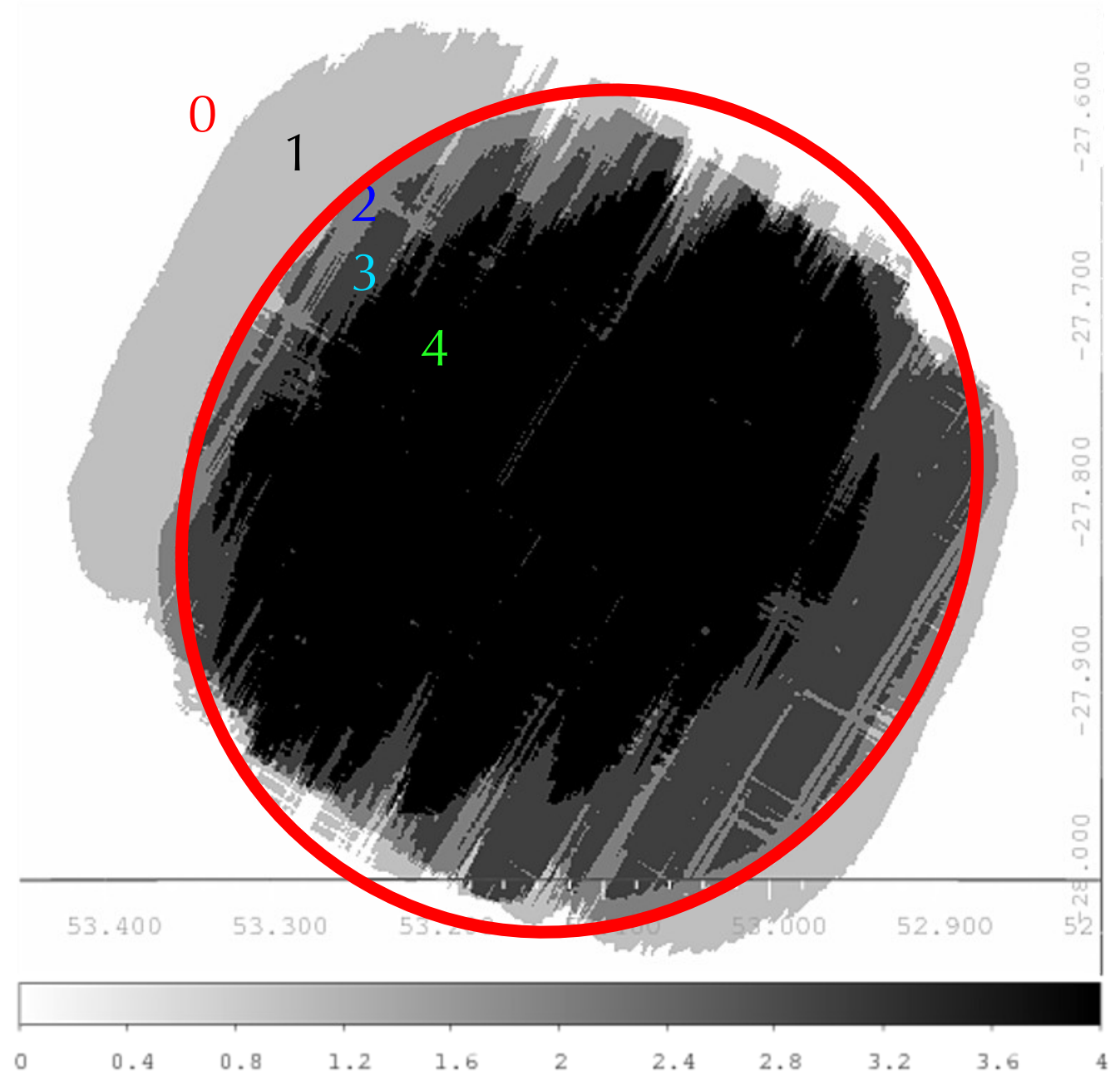


## Fake sources



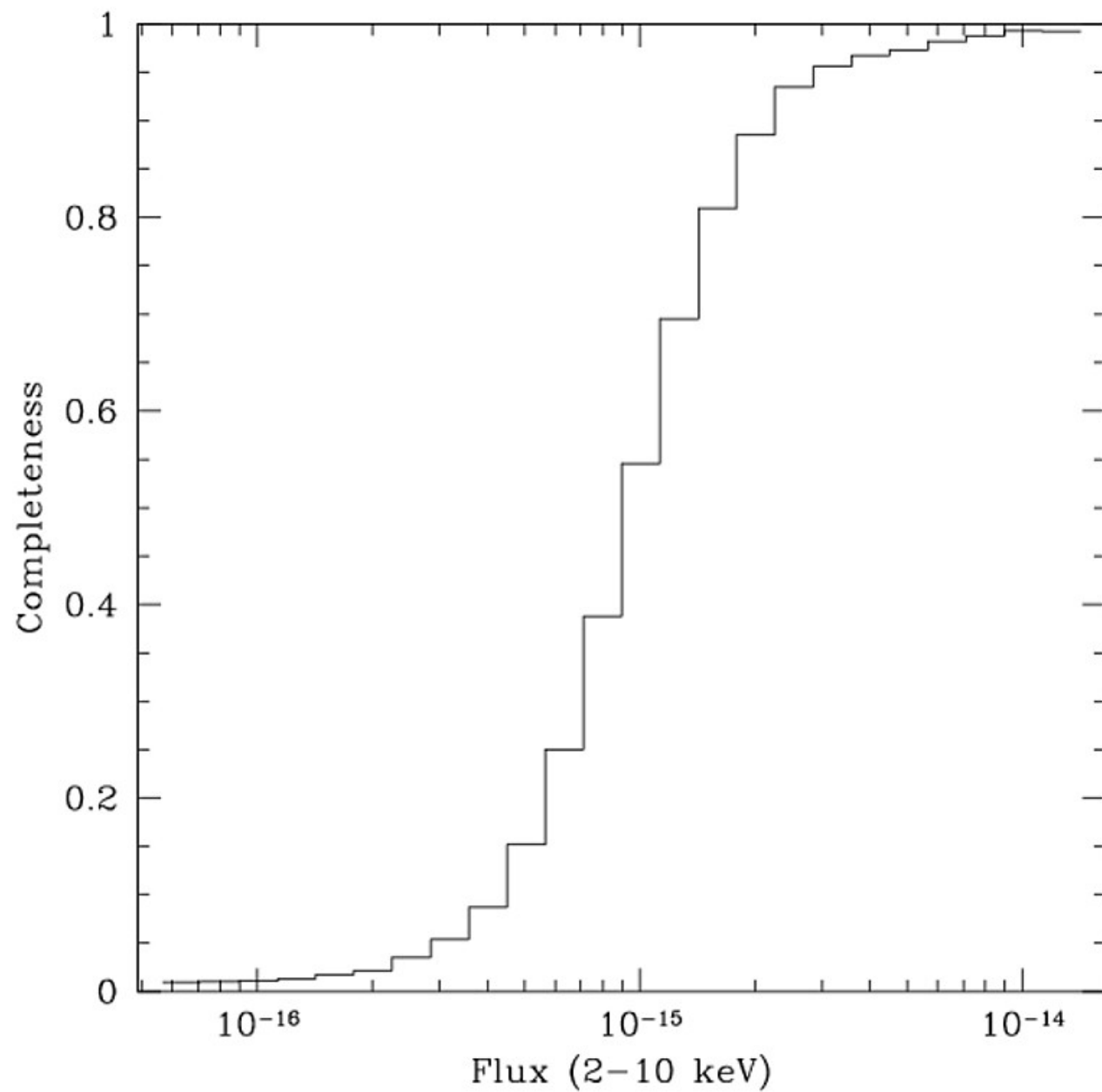
# Definition of “most reliable” area

$\text{detmask} \geq 2$



# Completeness

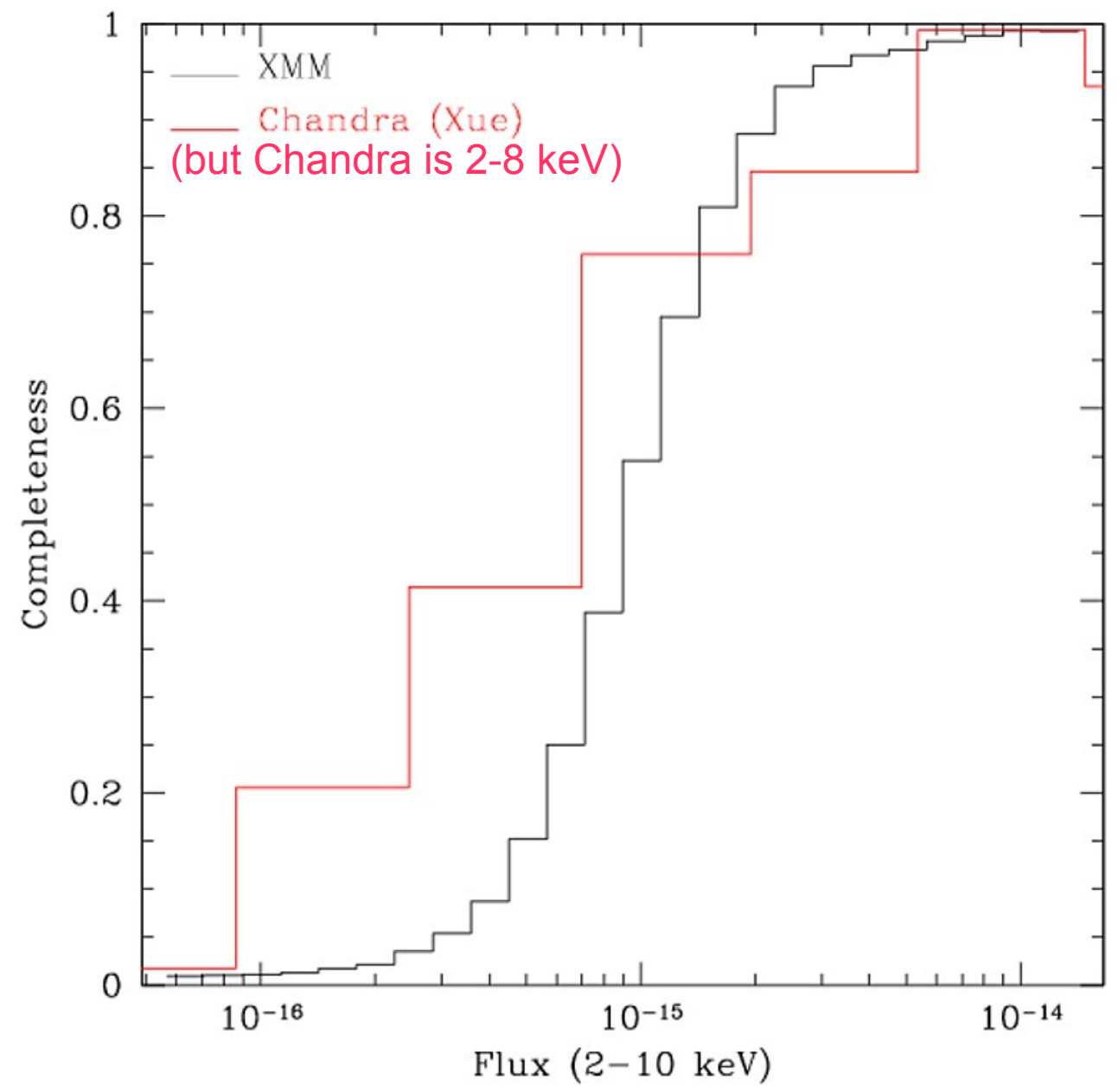
$$C(F) = \frac{N(\text{det})}{N(\text{sim})} \Big|_F$$



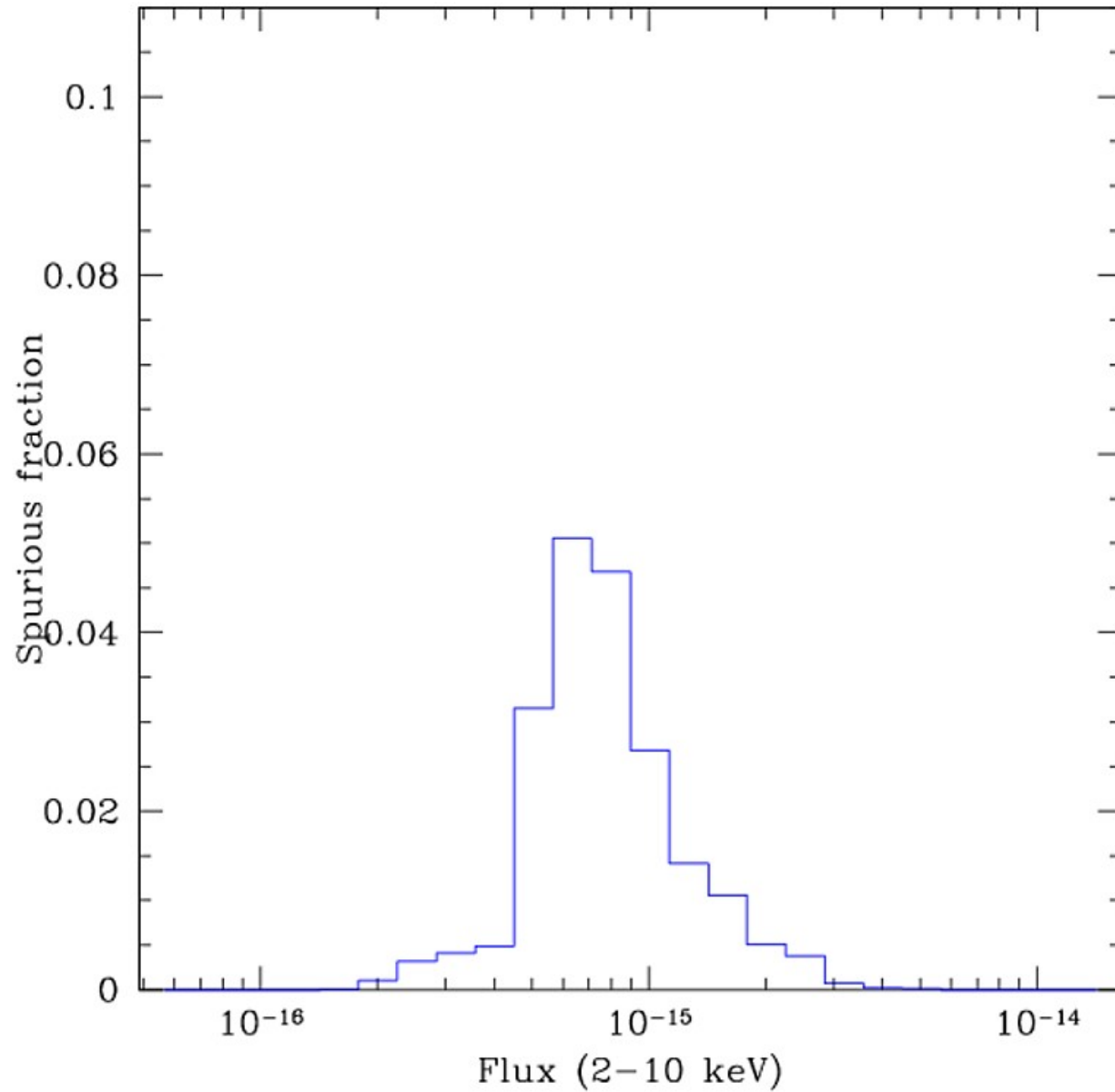
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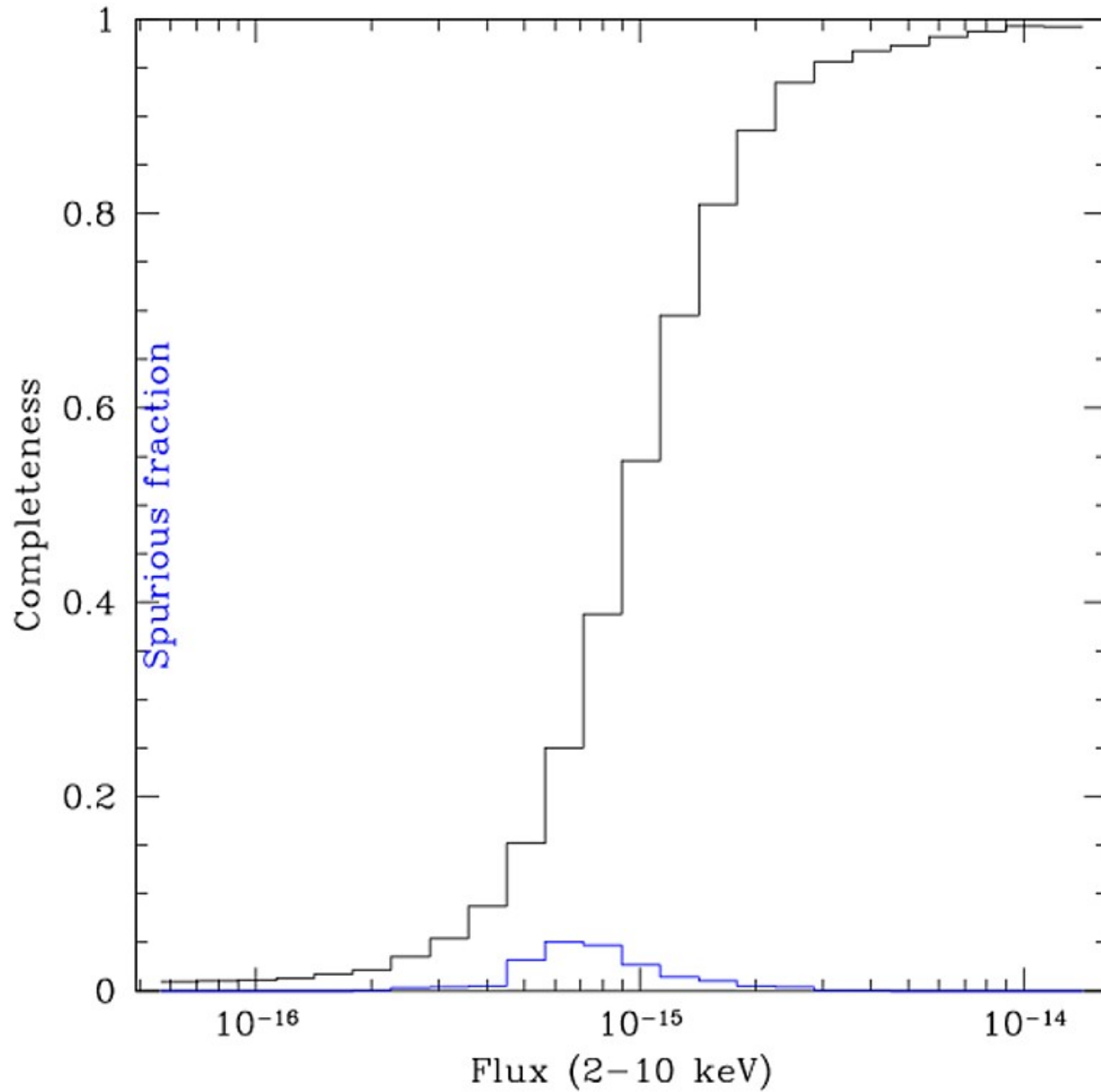
Chandra may go fainter,  
but XMM has much better  
completeness in the  
 $10^{-15}$  decade



Spurious fraction (  $N(\text{fake})/N(\text{sim})$  )



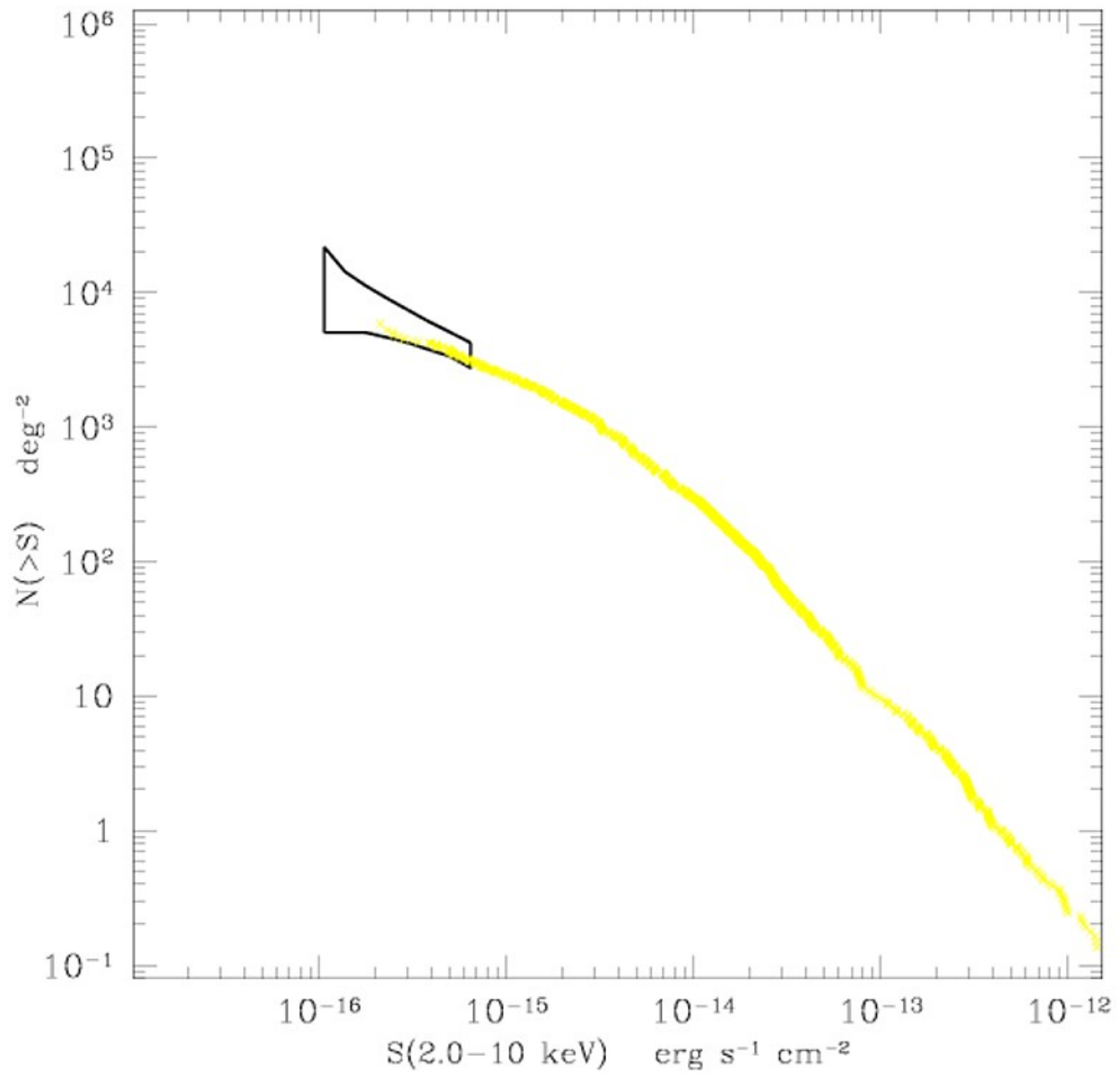
Spurious fraction (  $N(\text{fake})/N(\text{sim})$  )





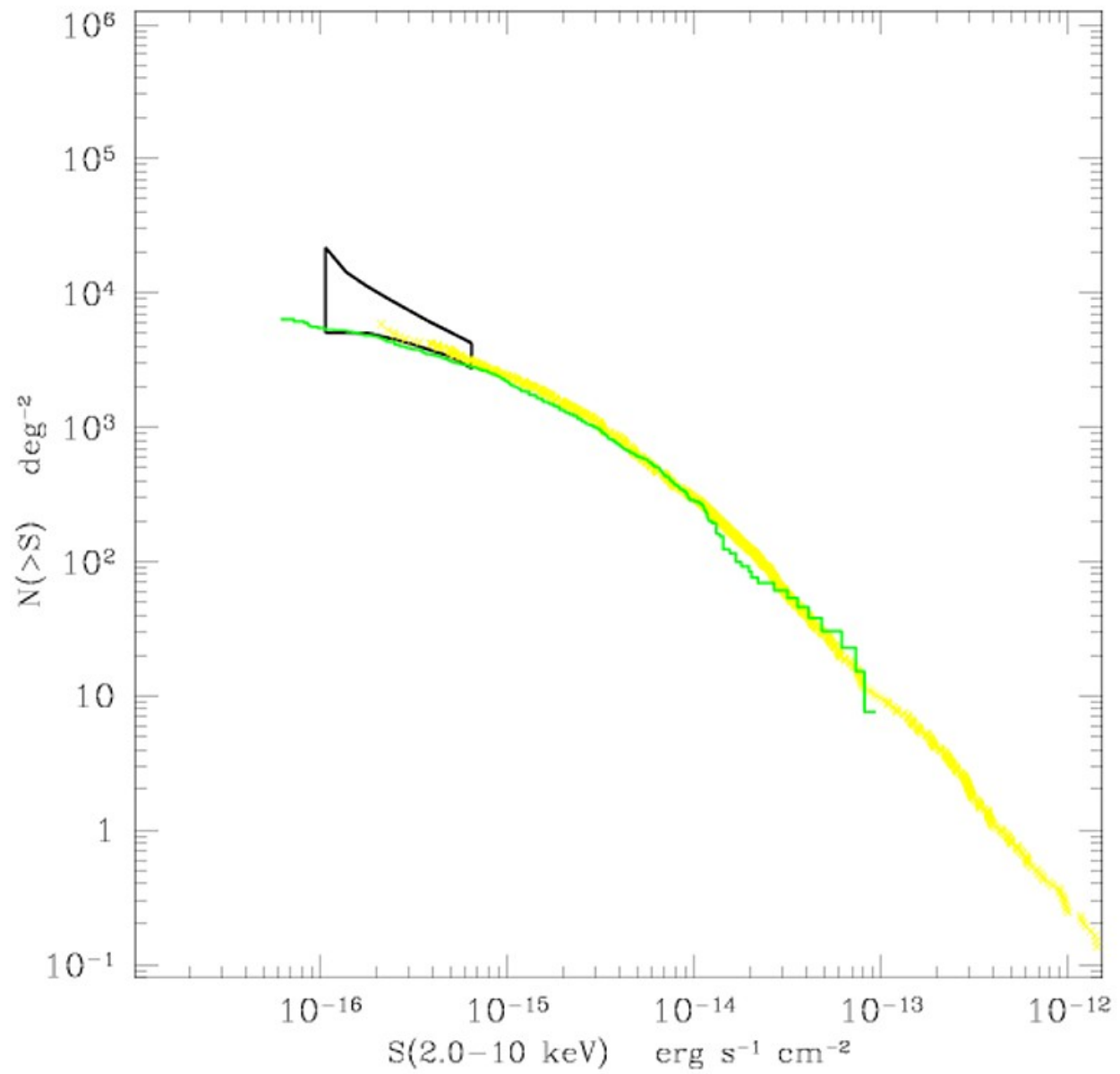
# 2-10 keV LogN-LogS

Moretti+Miyaji:

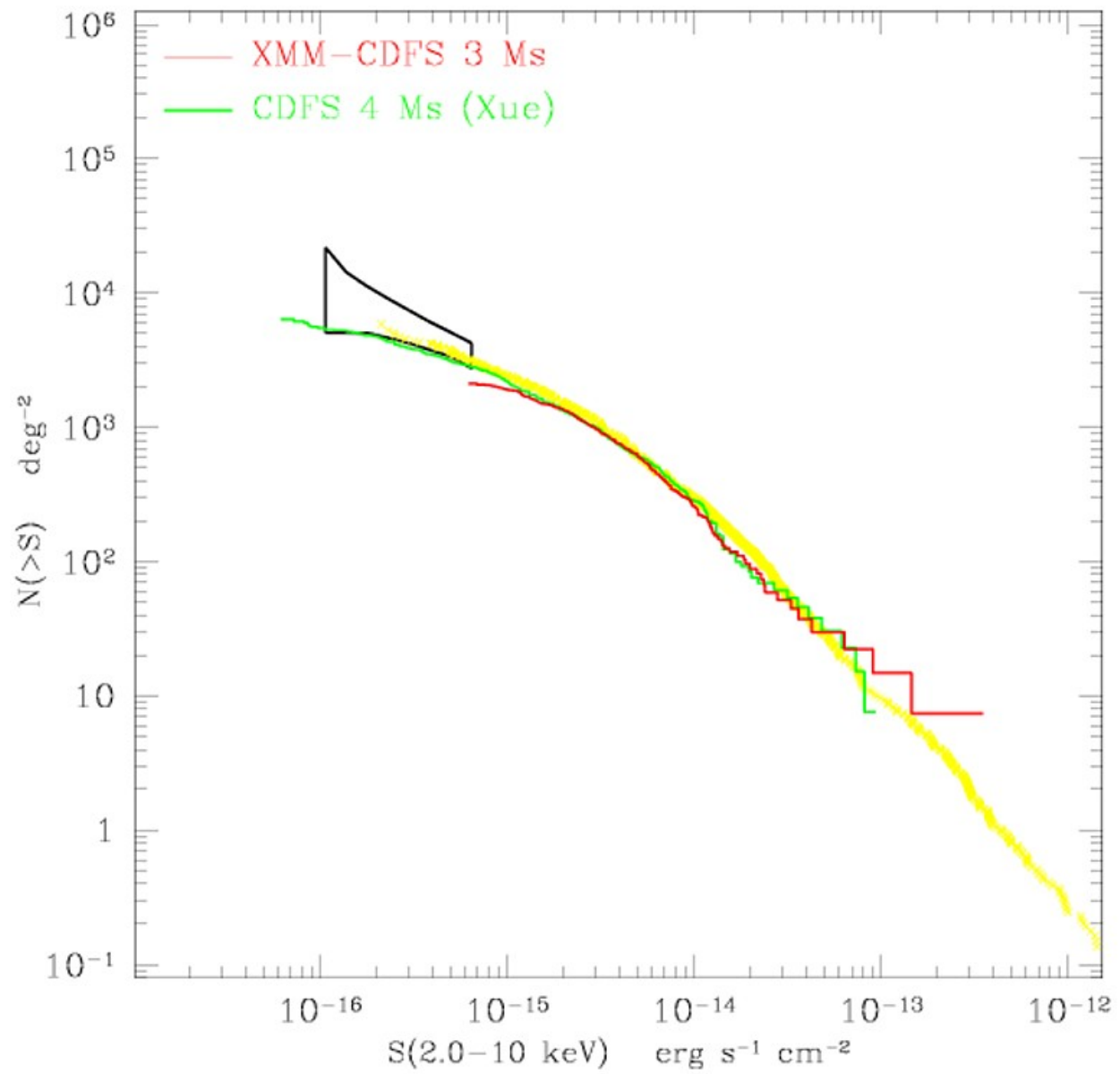


# 2-10 keV LogN-LogS

Xue:



# 2-10 keV LogN-LogS



## Conclusions

The P34H\_210 catalogue has been validated by extensive simulations, which have characterised it in terms of **completeness, reliability, and flux limit.**

Next steps:

- \* Fraction of confused sources
- \* Is it possible to go deeper?
- \* 5-10 keV where we should have real advantage over Chandra